











TAS6424M-Q1

ZHCSJB8 - FEBRUARY 2019

TAS6424M-Q1 45W、2MHz 数字输入 4 通道汽车用 D 类音频放大器(具有负载突降保护和²C 诊断功能)

1 特性

- 符合面向汽车应用的 AEC-Q100 应用
 - 器件温度等级 1: -40°C 至 +125°C T_A
- 高级负载诊断
 - 无需输入时钟即可进行直流诊断
 - 交流诊断可进行高频扬声器检测,提供阻抗和相位响应
- 可轻松满足 CISPR25-L5 EMC 规范
- 音频输入
 - 4 通道 I²S 或 4/8 通道 TDM 输入
 - 输入采样率: 44.1kHz、48kHz、96kHz
 - 输入格式: 16 位至 32 位 I²S 和 TDM
- 音频输出
 - 四通道桥接式负载 (BTL)
 - 双通道并联桥接式负载 (PBTL)
 - 高达 2.1MHz 的输出开关频率
 - 在 4Ω 负载、14.4V 电源电压和 10% THD 的条件下,输出功率为 27W BTL
 - 在 2Ω 负载、14.4V 电源电压和 10% THD 条件下,输出功率为 45W BTL
 - 在 2Ω 负载、18V PBTL 和 10% THD 的条件 下,输出功率为 80W
- 在 4Ω 负载和 14.4V 电源电压条件下的音频性能 BTL
 - 输出功率为 1W 时, THD+N < 0.02%
 - 42µV_{RMS} 输出噪声
 - -90dB 串扰
- 负载诊断功能
 - 输出负载开路和短路
 - 输出至电池短路或接地短路
 - 线路输出检测高达 6kΩ
 - 独立于主机运行
- 保护
 - 输出限流
 - 输出短路保护
 - 40V 负载突降
 - 可承受接地开路和电源开路
 - 直流偏移
 - 一 过热
 - 欠压和过压
- 常规运行
 - 4.5V 至 18V 电源电压

- I2C 控制具有 4 个地址选项
- 削波检测 及热告警

2 应用

- 汽车音响主机
- 汽车外部放大器

3 说明

TAS6424M-Q1 器件是一款四通道数字输入 D 类音频放大器,其实现了 2.1MHz PWM 开关频率,并以非常小的 PCB 尺寸实现了成本优化的解决方案,可针对启停事件在低至 4.5V 的电压下全面运行,并可在高达40kHz 的音频带宽下提供出色的音质。

输出开关频率既可以设置为高于调幅 (AM) 频带,以消除 AM 频带干扰并降低输出滤波需求及成本;也可以设置为低于 AM 频带,以优化器件效率。

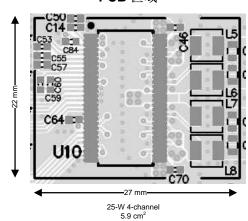
该器件具有内置负载诊断功能,用于检测和诊断误接的 输出,以及检测交流耦合的高频扬声器,以帮助缩短制 造过程中的测试时间。。

器件信息(1)

器件型号	封装	封装尺寸 (标称值)
TAS6424M-Q1	HSSOP (56)	18.41mm × 7.49mm

(1) 如需了解所有可用封装,请参阅数据表末尾的可订购产品附录。

PCB 区域



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			# = #	

4 修订历史记录

注: 之前版本的页码可能与当前版本有所不同。

日期	修订版本	说明
2019 年 2 月	*	初始发行版。



5 说明(续)

TAS6424M-Q1 D 类音频放大器专为汽车音响主机和外部放大器模块而设计。在 14.4V 电源电压条件下,当负载为 4Ω 、THD+N 为 10% 时,该器件可提供 四 通道的 27W 输出功率;当负载为 2Ω 、THD+N 为 10% 时,该器件可提供 45W 的输出功率。

有关引脚兼容的单通道、双通道及四通道器件,请参见 TAS6421-Q1、TAS6422-Q1、TAS6424L-Q1 及 TAS6424-Q1。

TEXAS INSTRUMENTS

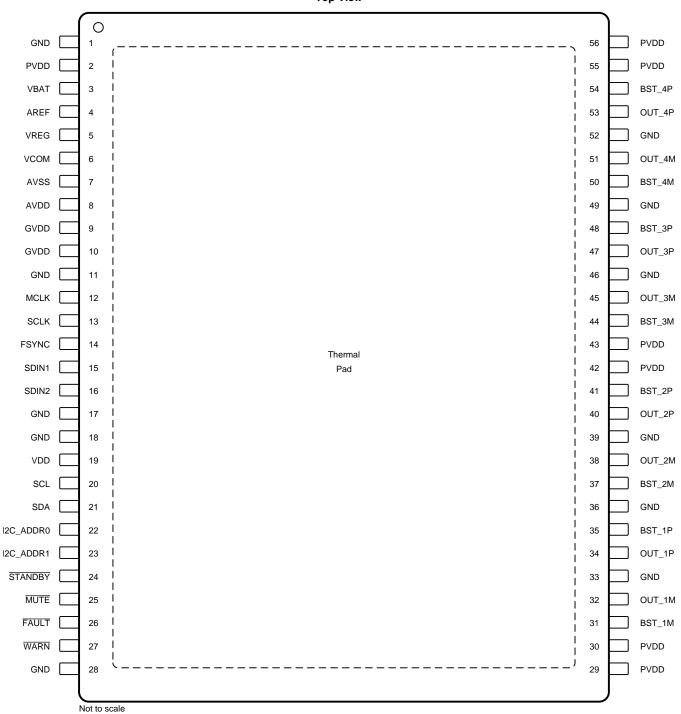
6 Device Options

	Channel	Device Cumply	Current		Output Powe	er / 10% THD	
Part Number	Count	Power-Supply Voltage Range	Limit (Typ)	4 Ω / BTL 14.4 V	4 Ω / BTL Max Voltage	2 Ω / BTL 14.4 V	2 Ω / PBTL Max Voltage
TAS6424-Q1	4	4.5 V to 26.4 V	6.5 A	27 W	75 W at 25 V	45 W	150 W at 25 V
TAS6424M-Q1	4	4.5 V to 18 V	6.5 A	27 W	45 W at 18 V	45 W	80 W at 18 V
TAS6424L-Q1	4	4.5 V to 18 V	4.8 A	27 W	45 W at 18 V	27 W	80 W at 18 V
TAS6422-Q1	2	4.5 V to 26.4 V	6.5 A	27 W	75 W at 25 V	45 W	150 W at 25 V
TAS6421-Q1	1	4.5 V to 26.4 V	6.5 A	27 W	75 W at 25 V	45 W	N/A



7 Pin Configuration and Functions

DKQ Package 56-Pin HSSOP With Exposed Thermal Pad Top View



Pin Functions

	Pin Functions PIN (1)						
	I	TYPE(1)	DESCRIPTION				
NAME	NO.	DWD	VDEC and VCOM by race consister veture				
AREF	4	PWR	VREG and VCOM bypass capacitor return				
AVDD	8	PWR	Voltage regulator bypass. Connect 1 µF capacitor from AVDD to AVSS				
AVSS	7	PWR	AVDD bypass capacitor return				
BST_1M	31	PWR	Bootstrap capacitor connection pins for high-side gate driver				
BST_1P	35	PWR	Bootstrap capacitor connection pins for high-side gate driver				
BST_2M	37	PWR	Bootstrap capacitor connection pins for high-side gate driver				
BST_2P	41	PWR	Bootstrap capacitor connection pins for high-side gate driver				
BST_3M	44	PWR	Bootstrap capacitor connection pins for high-side gate driver				
BST_3P	48	PWR	Bootstrap capacitor connection pins for high-side gate driver				
BST_4M	50	PWR	Bootstrap capacitor connection pins for high-side gate driver				
BST_4P	54	PWR	Bootstrap capacitor connection pins for high-side gate driver				
FAULT	26	DO	Reports a fault (active low, open drain), 100-kΩ internal pull-up resistor				
FSYNC	14	DI	Audio frame clock input				
GND	1, 11, 17, 18, 28, 33, 36, 39, 46, 49, 52	GND	Ground				
GVDD	9	PWR	Gate drive voltage regulator derived from VBAT input pin. Connect 2.2 µF capacitor to GND				
GVDD	10	FWK	Gate drive voltage regulator derived from VBAT input pin. Connect 2.2 µF capacitor to GND				
I2C_ADDR0	22	DI	I ² C address pins. Refer to 表 8				
I2C_ADDR1	23	וט	T C address pills. Refer to 衣 o				
MCLK	12	DI	Audio master clock input				
MUTE	25	DI	Mutes the device outputs (active low) while keeping output FETs switching at 50%, 100-k Ω internal pull-down resistor				
OUT_1M	32	NO	Negative output for the channel				
OUT_1P	34	РО	Positive output for the channel				
OUT_2M	38	NO	Negative output for the channel				
OUT_2P	40	РО	Positive output for the channel				
OUT_3M	45	NO	Negative output for the channel				
OUT_3P	47	РО	Positive output for the channel				
OUT_4M	51	NO	Negative output for the channel				
OUT_4P	53	РО	Positive output for the channel				
PVDD	2, 29, 30, 42, 43, 55, 56	PWR	PVDD voltage input (can be connected to battery). Bulk capacitor and bypass capacitor required				
SCL	20	DI	I ² C clock input				
SCLK	13	DI	Audio bit and serial clock input				
SDA	21	DI/O	I ² C data input and output				
SDIN1	15	DI	TDM data input and audio I ² S data input for channels 1 and 2				
SDIN2	16	DI	Audio I ² S data input for channels 3 and 4				
STANDBY	24	DI	Enables low power standby state (active Low), 100-kΩ internal pull-down resistor				
VBAT	3	PWR	Battery voltage input				
VCOM	6	PWR	Bias voltage				
VDD	19	PWR	3.3-V external supply voltage				
VREG	5	PWR	Voltage regulator bypass				
WARN	27	DO	Clip and overtemperature warning (active low, open drain), 100-kΩ internal pull-up resistor				
Thermal Pad	_	GND	Provides both electrical and thermal connection for the device. Heatsink must be connected to GND.				

⁽¹⁾ GND = ground, PWR = power, PO = positive output, NO = negative output, DI = digital input, DO = digital output, DI/O = digital input and output, NC = no connection



8 Specifications

8.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
PVDD, VBAT	DC supply voltage relative to GND		-0.3	30	٧
V _{MAX}	Transient supply voltage: PVDD, VBAT	t ≤ 400 ms exposure	-1	40	٧
V_{RAMP}	Supply-voltage ramp rate: PVDD, VBAT	•		75	V/ms
VDD	DC supply voltage relative to GND			3.5	V
I _{MAX}	Maximum current per pin (PVDD, VBAT, OUT_xP, OUT_xM, GND)			8	Α
I _{MAX_PULSED}	Pulsed supply current per PVDD pin (one shot)	t < 100 ms		12	Α
V _{LOGIC}	Input voltage for logic pins (SCL, SDA, SDIN1, SDIN2, STANDBY, I2C_ADDRx)	MCLK, BCLK, LRCLK, MUTE,	-0.3	VDD + 0.5	V
V_{GND}	Maximum voltage between GND pins			0.3	V
TJ	Maximum operating junction temperature		-55	150	°C
T _{stg}	Storage temperature		-55	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

8.2 ESD Ratings

				VALUE	UNIT
\/(EQD)	Electrostatic	Human-body model (HBM), per AEC Q100–002 ⁽¹⁾ HBM ESD Classification Level 2		±3000	
	discharge	Charged-device model (CDM), per AEC Q100-011	All pins	±500	V
			Corner pins (1, 28, 29 and 56)	±1000	

⁽¹⁾ AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.



8.3 Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
PVDD	Output FET supply voltage	Relative to GND	4.5		18	V
VBAT	Battery supply voltage input	Relative to GND	4.5	14.4	18	V
VDD	DC logic supply	Relative to GND	3.0	3.3	3.5	V
T _A	Ambient temperature		-40		125	°C
TJ	Junction temperature	An adequate thermal design is required	-40		150	°C
_	Nominal speaker load impedance	BTL Mode	2	4		0
R _L		PBTL Mode	1	2		Ω
R _{PU_I2C}	I ² C pullup resistance on SDA and SCL pins		1	4.7	10	kΩ
C _{Bypass}	External capacitance on bypass pins	Pin 2, 3, 5, 6, 8, 19		1		μF
C _{GVDD}	External capacitance on GVDD pins	Pin 9, 10		2.2		μF
C _{OUT}	External capacitance to GND on OUT pins	Limit set by DC-diagnostic timing		1	3.3	μF
Lo	Output filter inductance	Minimum inductance at I _{SD} current levels	1			μH

8.4 Thermal Information

	TAS64		24M-Q1 ⁽²⁾	TAS6424M-Q1 ⁽³⁾	
	THERMAL METRIC ⁽¹⁾	DKQ (HSSOP)	DKQ (HSSOP)	UNIT
		56	PINS	56 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	3	8.8	_	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	().3	1.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	1	6.0	_	°C/W
ΨЈТ	Junction-to-top characterization parameter	().1	_	°C/W
ΨЈВ	Junction-to-board characterization parameter	1-	4.6	10	°C/W
R ₀ JC(bot)	Junction-to-case (bottom) thermal resistance	r	n/a	_	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report (SPRA953).

⁽²⁾ JEDEC Standard 4 Layer PCB.

⁽³⁾ Measured using the TÁS6424M-Q1 EVM layout and heat sink. The device is not intended to be used without a heat sink.



8.5 Electrical Characteristics

Test conditions (unless otherwise noted): $T_C = 25^{\circ}C$, PVDD = VBAT = 14.4 V, VDD = 3.3 V, $R_L = 4~\Omega$, $P_{out} = 1~W/ch$, f = 1~kHz, $f_{SW} = 2.11~MHz$, AES17 Filter, default I^2C settings, see $\boxed{8}$ 79

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OPERATING	CURRENT					
I _{PVDD_IDLE}	PVDD idle current	All channels playing, no audio input		75	90	mA
I _{VBAT_IDLE}	VBAT idle current	All channels playing, no audio input		90	100	mA
I _{PVDD_STBY}	PVDD standby current	STANDBY Active, VDD = 0 V		0.5	1	μА
I _{VBAT_STBY}	VBAT standby current	STANDBY Active, VDD = 0 V		4	6	μА
I_{VDD}	VDD supply current	All channels playing, -60-dB signal		15	18	mA
OUTPUT POV	VER					
		4 Ω , PVDD = 14.4 V, THD+N = 1%, T _C = 75°C	20	22		
		4 Ω , PVDD = 14.4 V, THD+N = 10%, T _C = 75°C	25	27		
P _{O_BTL}	Output power per channel, BTL	2 Ω , PVDD = 14.4 V, THD+N = 1%, T _C = 75°C	38	40		W
FO_BTL	Output power per charmer, BTE	2 Ω , PVDD = 14.4 V, THD+N = 10%, T _C = 75°C	42	45		VV
		4 Ω , PVDD = 18 V, THD+N = 1%, T _C = 75°C	30	33		
		4 Ω , PVDD = 18 V, THD+N = 10%, T _C = 75°C	40	45		
		2 Ω , PVDD = 14.4 V, THD+N = 1%, T _C = 75°C	35	40		
		2 Ω , PVDD = 14.4 V, THD+N = 10%, T _C = 75°C	45	50		
P _{O PBTL}	Output power per channel in parallel	1 Ω , PVDD = 14.4 V, THD+N = 1%, T _C = 75°C	72	80		W
O_PBIL	mode, PBTL	1 Ω , PVDD = 14.4 V, THD+N = 10%, T _C = 75°C	80	90		
		2 Ω, PVDD = 18 V, THD+N = 1%, T _C = 75°C	60	65		
		2 Ω, PVDD = 18 V, THD+N = 10%, T _C = 75°C	75	80		
EFF _P	Power efficiency	4 channels operating, 25 W output power/ch, 4 Ω load, PVDD = 14.4 V, T _C = 25°C, including inductor losses(1)		86%		
AUDIO PERF	ORMANCE					
		Zero input, A-weighting, gain level 1, PVDD = 14.4 V		42		
V	Output noise voltage	Zero input, A-weighting, gain level 2, PVDD = 14.4 V		55		μV
V _n	Output Hoise voltage	Zero input, A-weighting, gain level 3, PVDD = 18 V		67		μν
		Zero input, A-weighting, gain level 4, PVDD = 18 V		85		
		Gain level 1, Register 0x01, bit 1-0 = 00		7.5		
GAIN	Peak output voltage/dBFS	Gain level 2, Register 0x01, bit 1-0 = 01		15		V/FS
O/ 1114	r dan darpar vonago, abi d	Gain level 3, Register 0x01, bit 1-0 = 10		21		,,,,,
		Gain level 4, Register 0x01, bit 1-0 = 11		29		
Crosstalk	Channel crosstalk	$PVDD = 14.4 \text{ Vdc} + 1 \text{ V}_{RMS}, f = 1 \text{ kHz}$		-90		dB
PSRR	Power-supply rejection ratio	$PVDD = 14.4 \text{ Vdc} + 1 \text{ V}_{RMS}, f = 1 \text{ kHz}$		75		dB
THD+N	Total harmonic distortion + noise			0.02%		
G _{CH}	Channel-to-channel gain variation		-0.5	0	0.5	dB
	T PERFORMANCE					,
$V_{n_LINEOUT}$	Line output noise voltage	Zero input, A-weighting, channel set to LINE MODE		42		μV
V _{O_LINEOUT}	Line output voltage	0-dB input, channel set to LINE MODE		5.5		V _{RMS}
THD+N	Line output total harmonic distortion + noise	$V_{\rm O}$ = 2 $V_{\rm RMS}$, channel set to LINE MODE		0.01%		
DIGITAL INPU	JT PINS					
V _{IH}	Input logic level high		70			%VDD
V _{IL}	Input logic level low				30	%VDD
I _{IH}	Input logic current, high	V _I = VDD			15	μA
I _{IL}	Input logic current, low	V _I = 0			-15	μA
PWM OUTPU	T STAGE					
R _{DS(on)}	FET drain-to-source resistance	Not including bond wire and package resistance		90		mΩ
	GE (OV) PROTECTION		•			
V _{PVDD_OV}	PVDD overvoltage shutdown		19.3	20	22	V
V _{PVDD OV HYS}	PVDD overvoltage shutdown hysteresis			0.8		V
V _{VBAT_OV}	VBAT overvoltage shutdown		20	21.5	23	V



Electrical Characteristics (continued)

Test conditions (unless otherwise noted): $T_C = 25^{\circ}C$, PVDD = VBAT = 14.4 V, VDD = 3.3 V, $R_L = 4 \Omega$, $P_{out} = 1 \text{ W/ch}$, f = 1 kHz, $f_{SW} = 2.11 \text{ MHz}$, AES17 Filter, default I^2C settings, see $\boxed{8}$ 79

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{VBAT_OV_HYS}$	VBAT overvoltage shutdown hysteresis			0.6		V
UNDERVOLTA	AGE (UV) PROTECTION					
VBAT _{UV}	VBAT undervoltage shutdown			4	4.5	V
VBAT _{UV_HYS}	VBAT undervoltage shutdown hysteresis			0.2		V
PVDD _{UV}	PVDD undervoltage shutdown			4	4.5	V
PVDD _{UV_HYS}	PVDD undervoltage shutdown hysteresis			0.2		V
BYPASS VOL	TAGES					
V_{GVDD}	Gate drive bypass pin voltage			7		V
V _{AVDD}	Analog bypass pin voltage			6		V
V _{VCOM}	Common bypass pin voltage			2.5		V
V _{VREG}	Regulator bypass pin voltage			5.5		V
POWER-ON R	RESET (POR)					
V _{POR}	VDD voltage for POR			2.1	2.7	V
V _{POR_HY}	VDD POR recovery hysteresis voltage			0.5		V
OVERTEMPE	RATURE (OT) PROTECTION					
OTW(i)	Channel overtemperature warning			150		°C
OTSD(i)	Channel overtemperature shutdown			175		°C
OTW	Global junction overtemperature warning	Set by register 0x01 bit 5-6, default value		130		°C
OTSD	Global junction overtemperature shutdown			160		°C
OT _{HYS}	Overtemperature hysteresis			15		°C
LOAD OVER	CURRENT PROTECTION					
		OC Level 1	4	4.8		
I _{LIM}	Overcurrent cycle-by-cycle limit	OC Level 2	6	6.5		Α
		OC Level 1, Any short to supply, ground, or other channels		7		
I _{SD}	Overcurrent shutdown	OC Level 2, Any short to supply, ground, or other channels		9		Α
MUTE MODE						
G _{MUTE}	Output attenuation			100		dB
CLICK AND P	OP					
V _{CP}	Output click and pop voltage	ITU-R 2k filter, High-Z/MUTE to Play, Play to Mute/High-Z		7		mV
DC OFSET						
V _{OFFSET}	Output offset voltage			2	5	mV
DC DETECT					ļ	
DC _{FAULT}	Output DC fault protection			2	2.5	V
DIGITAL OUT	PUT PINS				ļ	
V _{OH}	Output voltage for logic level high	I = ±2 mA	90			%VDD
V _{OL}	Output voltage for logic level low	I = ±2 mA			10	%VDD
t _{DELAY_CLIPDET}	Signal delay when output clipping detected				20	μS
LOAD DIAGN	OSTICS				ļ	
S2P	Maximum resistance to detect a short from OUT pins to PVDD				500	Ω
S2G	Maximum resistance to detect a short from OUT pins to ground				200	Ω
SL	Shorted load detection tolerance	Other channels in Hi-Z			±0.5	Ω
OL	Open load	Other channels in Hi-Z	40	70		Ω
T _{DC_DIAG}	DC diagnostic time	All 4 Channels		230		ms
LO	Line output				6	kΩ
T _{LINE_DIAG}	Line output diagnostic time			40		ms
AC _{IMP}	AC impedance accuracy	Gain linearity, $f = 19$ kHz, $R_L = 2 \Omega$ to 16 Ω ,		-	25%	
_		Offset			±0.5	Ω
T _{AC_DIAG}	AC diagnostic time	All 4 Channels		520		ms



Electrical Characteristics (continued)

Test conditions (unless otherwise noted): $T_C = 25^{\circ}C$, PVDD = VBAT = 14.4 V, VDD = 3.3 V, $R_L = 4 \Omega$, $P_{out} = 1 \text{ W/ch}$, f = 1 kHz, $f_{SW} = 2.11 \text{ MHz}$, AES17 Filter, default I^2C settings, see $\boxed{8}$ 79

	PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT					
I2C_ADDR P	I2C_ADDR PINS									
t _{I2C_ADDR}	Time delay needed for I ² C address set-up			300	μS					

⁽¹⁾ Tested with Output Inductor DFEG7030D-3R3M.

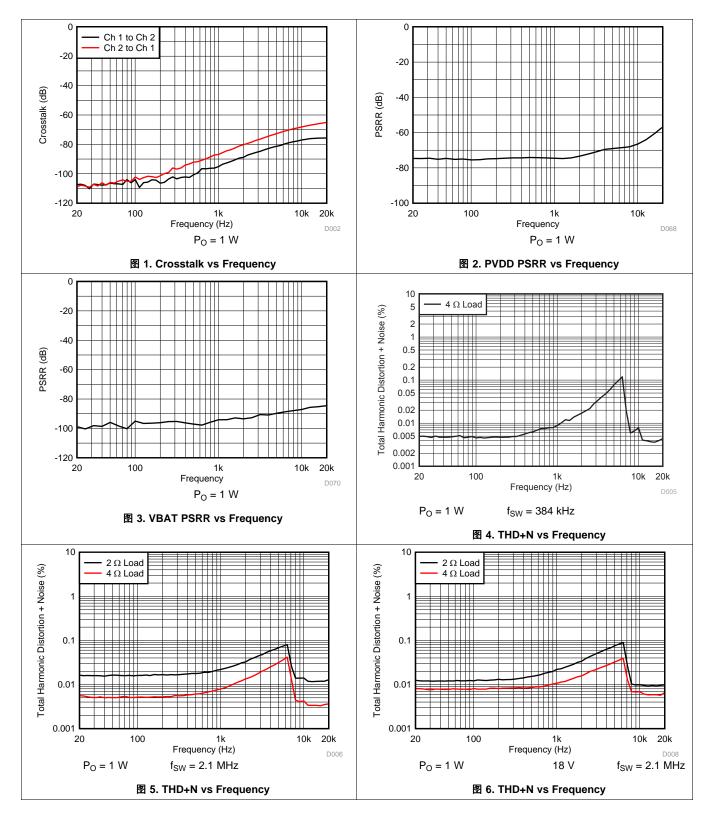
8.6 Timing Requirements

Test conditions (unless otherwise noted): $T_C = 25$ °C, PVDD = VBAT = 14.4 V, VDD = 3.3 V, $R_L = 4 \Omega$, $P_O = 1$ W/ch, f = 1 kHz, $f_{SW} = 2.11$ MHz, AES17 Filter, default I^2C settings, see 2.79

			MIN	TYP M	AX UN	NIT
² C CONTR	OL PORT (See 图 42)					
t _{BUS}	Bus free time between a STOP and START condit	ion	1.3		μ	μS
t _{HOLD1}	Hold time, SCL to SDA		0		n	ns
t _{HOLD2}	Hold time, start condition to SCL		0.6		μ	μS
t _{START}	I ² C startup time after VDD power on reset				12 m	ns
t _{RISE}	Rise time, SCL and SDA			3	00 n	ns
t _{FALL}	Fall time, SCL and SDA			3	00 n	ns
t _{SU1}	Setup, SDA to SCL		100		n	ns
t _{SU2}	Setup, SCL to start condition		0.6		μ	μS
t _{SU3}	Setup, SCL to stop condition		0.6		μ	μS
t _{W(H)}	Required pulse duration SCL High	0.6		μ	μS	
t _{W(L)}	Required pulse duration SCL Low		1.3		μ	μS
SERIAL AU	DIO PORT (See 图 32)					
D _{MCLK} , D _{SCLK}	Allowable input clock duty cycle		45%	50% 5	5%	
f_{MCLK}	Supported MCLK frequencies: 128, 256, or 512		128	5	12 xF	FS
f_{MCLK_Max}	Maximum frequency				25 MI	1Hz
t _{SCY}	SCLK pulse cycle time		40		n	ns
t _{SCL}	SCLK pulse-with LOW		16		n	ns
t _{SCH}	SCLK pulse-with HIGH		16		n	ns
t _{rise/fall}	Rise and fall time			<5	n	ns
t _{SF}	SCLK rising edge to FSYNC edge		8		n	ns
t _{FS}	FSYNC rising edge to SCLK edge		8		n	ns
t _{DS}	DATA set-up time		8		n	ns
t _{DH}	DATA hold time		8		n	ns
Ci	Input capacitance, pins MCLK, SCLK, FSYNC, SD	IN1, SDIN2			10 p	ρF
T	Latency from input to output measured in FSYNC	FSYNC = 44.1 kHz or 48 kHz			30	
T_LA	sample count	FSYNC = 96 kHz			12	

8.7 Typical Characteristics

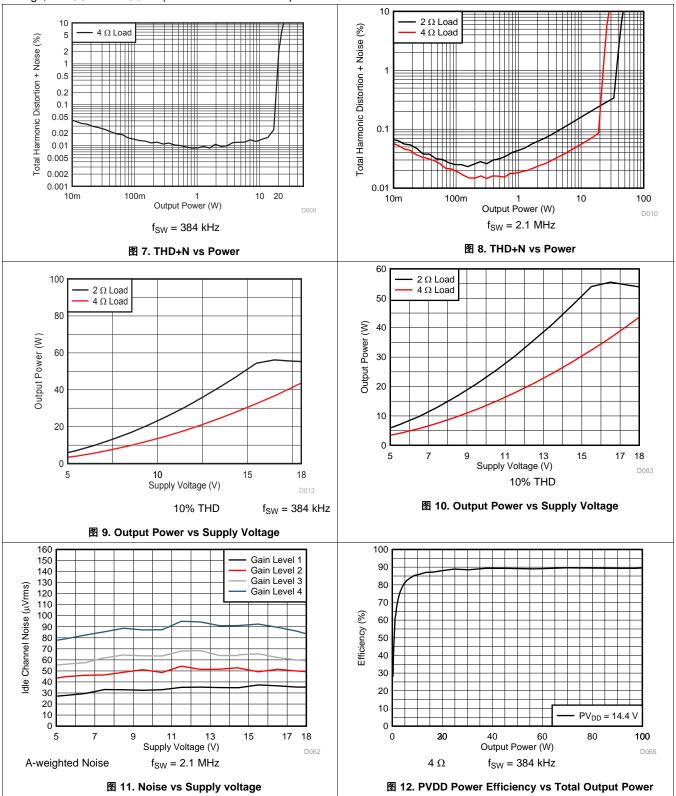
 T_A = 25 °C, V_{VDD} = 3.3 V, VBAT = PVDD = 14.4 V, R_L = 4 Ω , f_{IN} = 1 kHz, f_s = 48 kHz, f_{SW} = 2.1 MHz, AES17 filter, default I²C settings, see 2 79 and 2 82 (unless otherwise noted)





Typical Characteristics (接下页)

 $T_A = 25$ °C, $V_{VDD} = 3.3$ V, VBAT = PVDD = 14.4 V, $R_L = 4$ Ω , $f_{IN} = 1$ kHz, $f_s = 48$ kHz, $f_{SW} = 2.1$ MHz, AES17 filter, default I²C settings, see 2.79 and 2.20 (unless otherwise noted)



Typical Characteristics (接下页)

 T_A = 25 °C, V_{VDD} = 3.3 V, VBAT = PVDD = 14.4 V, R_L = 4 Ω , f_{IN} = 1 kHz, f_s = 48 kHz, f_{SW} = 2.1 MHz, AES17 filter, default I²C settings, see 3 79 and 3 82 (unless otherwise noted)

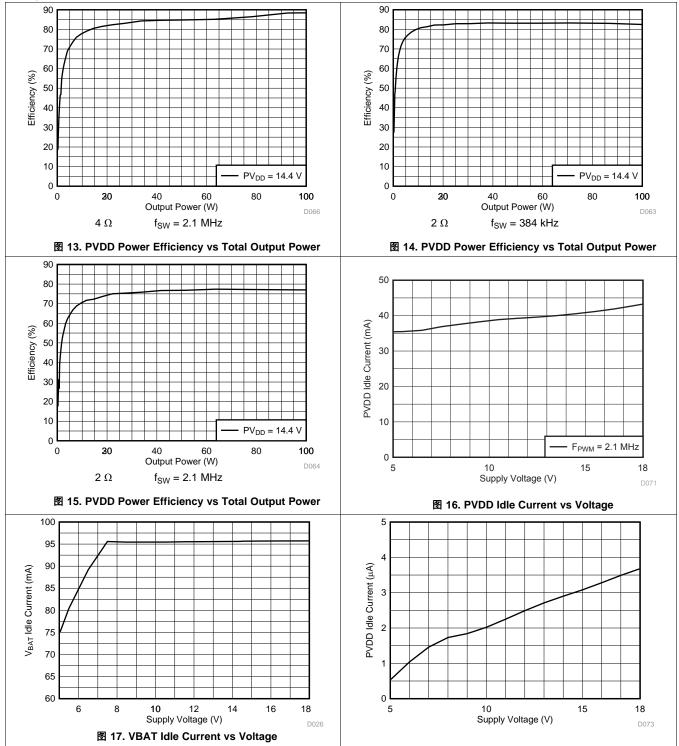
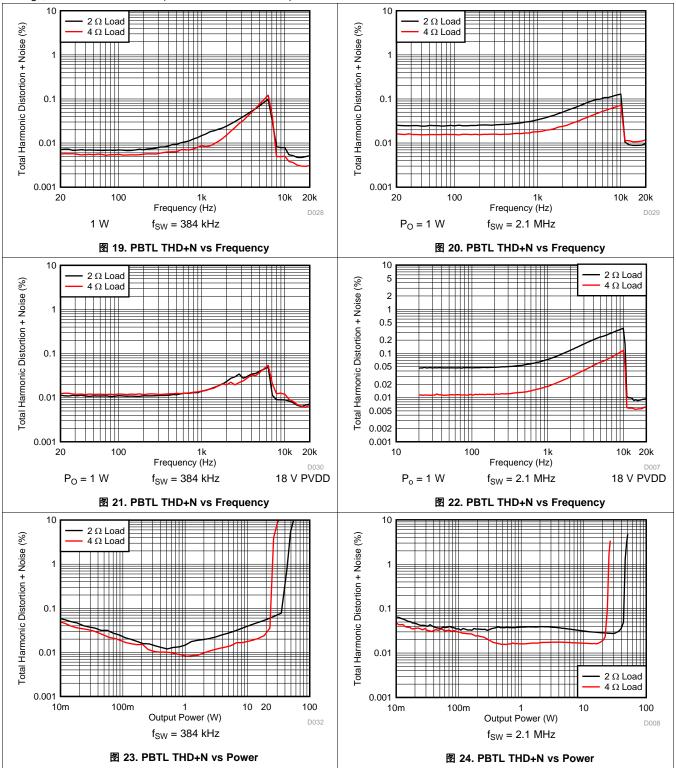


图 18. PVDD Standby Current vs Voltage



Typical Characteristics (接下页)

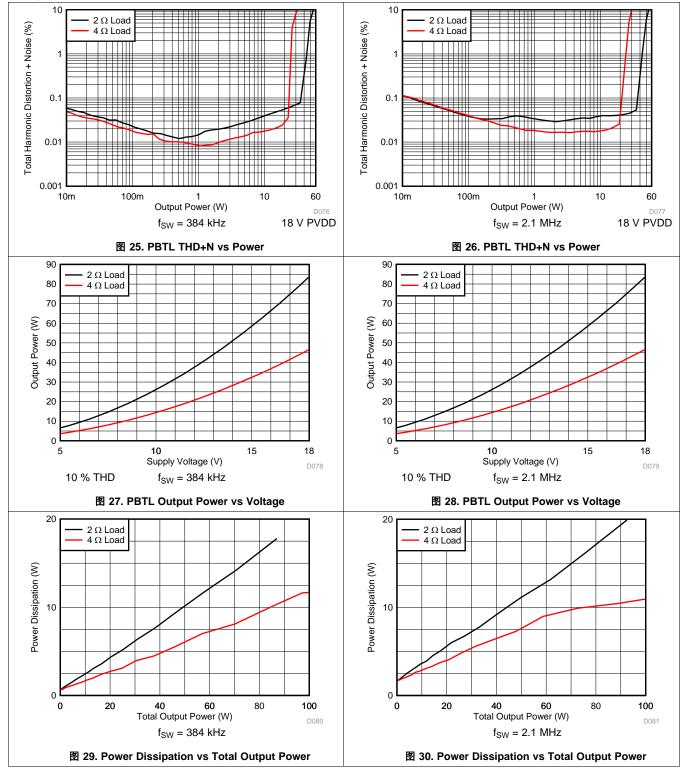
 $T_A = 25$ °C, $V_{VDD} = 3.3$ V, VBAT = PVDD = 14.4 V, $R_L = 4$ Ω , $f_{IN} = 1$ kHz, $f_s = 48$ kHz, $f_{SW} = 2.1$ MHz, AES17 filter, default I²C settings, see 2.79 and 2.20 (unless otherwise noted)



TEXAS INSTRUMENTS

Typical Characteristics (接下页)

 $T_A = 25$ °C, $V_{VDD} = 3.3$ V, VBAT = PVDD = 14.4 V, $R_L = 4$ Ω , $f_{IN} = 1$ kHz, $f_s = 48$ kHz, $f_{SW} = 2.1$ MHz, AES17 filter, default I²C settings, see 2.79 and 2.20 (unless otherwise noted)





9 Parameter Measurement Information

The parameters for the TAS6424M-Q1 device were measured using the circuit in ₹ 79.

For measurements with 2.1 MHz switching frequency the 3.3 µH inductor from the TAS6424M-Q1 EVM is used.

For measurements with 384 kHz switching frequency a 10 μ H inductor was used.

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TEXAS INSTRUMENTS

10 Detailed Description

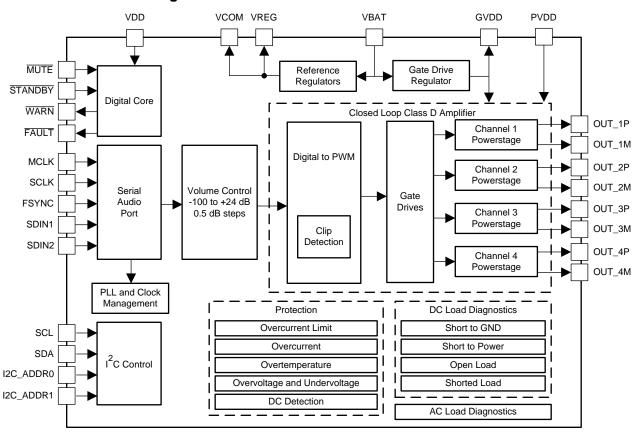
10.1 Overview

The TAS6424M-Q1 device is a four-channel digital-input Class-D audio amplifier specifically tailored for use in the in the automotive industry. The device is designed for vehicle battery operation. This ultra-efficient Class-D technology allows for reduced power consumption, reduced PCB area and reduced heat. The device realizes an audio sound-system design with smaller size and lower weight than traditional Class-AB solutions.

The core design blocks are as follows:

- Serial audio port
- · Clock management
- · High-pass filter and volume control
- Pulse width modulator (PWM) with output stage feedback
- Gate drive
- Power FETs
- Diagnostics
- Protection
- Power supply
- I²C serial communication bus

10.2 Functional Block Diagram



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10.3 Feature Description

10.3.1 Serial Audio Port

The serial audio port (SAP) receives audio in either I²S, left justified, right justified, or TDM formats.

Settings for the serial audio port are programmed in the SAP control register (address 0x03), see the SAP Control (Serial Audio-Port Control) Register (address = 0x03) [default = 0x04] section.

☑ 31 shows the digital audio data connections for I²S and TDM8 mode for an eight channel system.

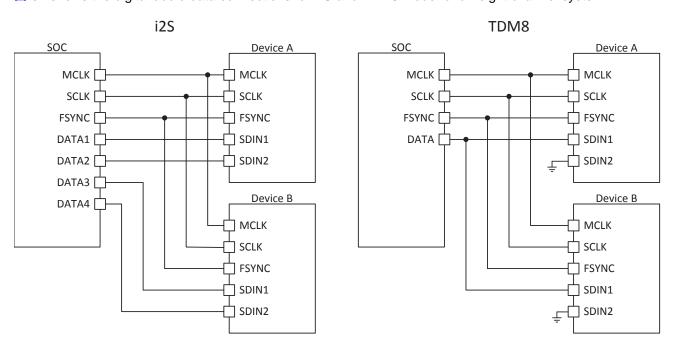


图 31. Digital-Audio Data Connection

10.3.1.1 PS Mode

I²S timing uses the FSYNC pin to define when the data being transmitted is for the left channel and when the data is for the right channel. The FSYNC pin is low for the left channel and high for the right channel. The bit clock, SCLK, runs at 32 \times f_S or 64 \times f_S and is used to clock in the data. A delay of one bit clock occurs from the time the FSYNC signal changes state to the first bit of data on the data lines. The data is presented in 2scomplement form (MSB-first). The data is valid on the rising edge of the bit clock and is used to clock in the data.

10.3.1.2 Left-Justified Timing

Left-justified (LJ) timing also uses the FSYNC pin to define when the data being transmitted is for the left channel and when the data is for the right channel. The FSYNC pin is high for the left channel and low for the right channel. A bit clock running at $32 \times f_S$ or $64 \times f_S$ is used to clock in the data. The first bit of data appears on the data lines at the same time FSYNC toggles. The data is written MSB-first and is valid on the rising edge of the bit clock. Digital words can be 16-bits or 24-bits wide and pad any unused trailing data-bit positions in the left-right (L/R) frame with zeros.

10.3.1.3 Right-Justified Timing

Right-justified (RJ) timing also uses the FSYNC pin to define when the data being transmitted is for the left channel and when the data is for the right channel. The FSYNC pin is high for the left channel and low for the right channel. A bit clock running at $32 \times f_S$ or $64 \times f_S$ is used to clock in the data. The first bit of data appears on the data 8-bit clock periods (for 24-bit data) after the FSYNC pin toggles. In RJ mode the LSB of data is always clocked by the last bit clock before the FSYNC pin transitions. The data is written MSB-first and is valid on the rising edge of bit clock. The device pads the unused leading data-bit positions in the L/R frame with zeros.

Feature Description (接下页)

10.3.1.4 TDM Mode

TDM mode supports 4 or 8 channels of audio data. The TDM mode is automatically selected when the TDM clocks are present. The device can be configured through I²C to use different stereo pairs in the TDM data stream. The TDM mode supports 16-bit, 24-bit, and 32-bit input data lengths.

In TDM mode, SCLK must be 128 x f_s or 256 x f_s , depending on the TDM slot size. In TDM mode SCLK and MCLK can be connected together. If SCLK and MCLK are connected together then FSYNC should be minimum 2 MCLK pulses long.

In TDM mode, the SDIN1 pin (pin 15) is used for digital audio data. TI recommends to connect the unused SDIN2 pin (pin 16) to ground. 表 1 lists register settings for the TDM channel selection.

REGISTER SETTING TDM8 CHANNEL SLOT 0x03 0x03 2 3 7 1 4 5 6 8 BIT 5 BIT 3 0 0 CH1 CH₂ CH3 CH4 1 0 CH1 CH2 CH3 CH4 0 1 CH3 CH4 CH1 CH2 CH3 CH4 CH1 CH₂

表 1. TDM Channel Selection

If PBTL mode is programmed for channel 1/2 or channel 3/4 the datasource can be set according to 表 2.

RE	GISTER SE	TTING				TDM8 CHAI	NNEL SLOT			
0x03 BIT 5	0x03 BIT 3	0x21 BIT 6	1	2	3	4	5	6	7	8
0	0	0	PBTL CH1/2	_	PBTL CH3/4	_	_	_	_	_
1	0	0	_	_	_	_	PBTL CH1/2	_	PBTL CH3/4	_
0	0	1	_	PBTL CH1/2	ı	PBTL CH3/4	_	_	_	_
1	0	1	_	_	_	_	_	PBTL CH1/2	_	PBTL CH3/4
0	1	0	PBTL CH3/4	_	PBTL CH1/2	_	_	_	_	_
1	1	0	_	_		_	PBTL CH3/4	_	PBTL CH1/2	_
0	1	1	_	PBTL CH3/4		PBTL CH1/2	_	_	_	_
1	1	1	_	_	_	_	_	PBTL CH3/4	_	PBTL CH1/2

表 2. TDM Channel Selection in PBTL Mode

10.3.1.5 Supported Clock Rates

The device supports MCLK rates of 128 \times f_S, 256 \times f_S, or 512 \times f_S.

The device supports SCLK rates of 32 \times f_S or 64 \times f_S in I²S, LJ or RJ modes or 128 \times f_S, or 256 \times f_S in TDM mode.

The device supports FSYNC rates of 44.1 kHz, 48 kHz, or 96 kHz.

The maximum clock frequency is 25 MHz. Therefore, for a 96 kHz FSYNC rate, the maximum MCLK rate is $256 \times f_S$.

The MCLK clock must not be in phase to sync to SCLK. Duty cycle of 50% is required for 128x FSYNC, for 256x and 512x 50% duty is not required.

10.3.1.6 Audio-Clock Error Handling

When any kind of clock error, MCLK-FSYNC or SCLK-FSYNC ratio, or clock halt is detected, the device puts all channels into the Hi-Z state. When all audio clocks are within the expected range, the device automatically returns to the state it was in. See the *Timing Requirements* table for timing requirements.

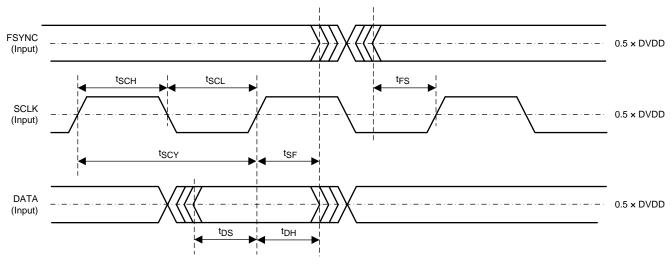


图 32. Serial Audio Timing

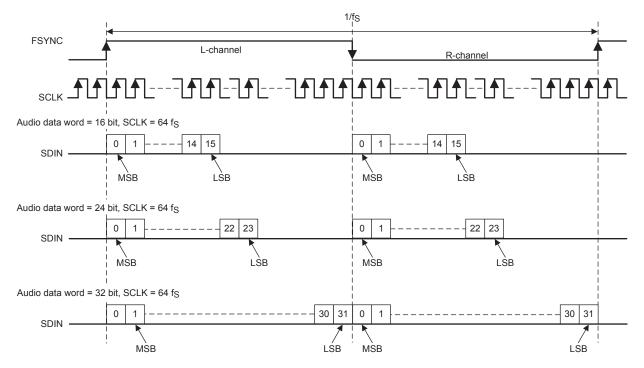


图 33. Left-Justified Audio Data Format



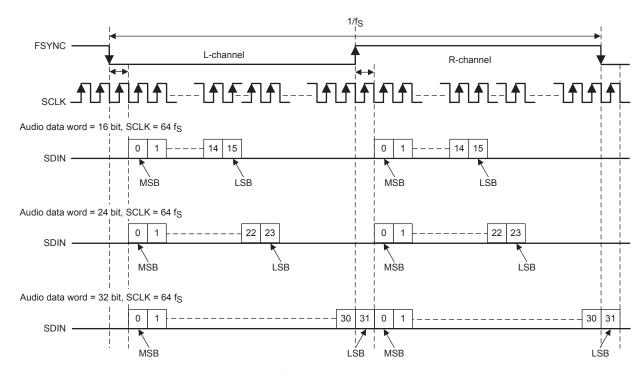
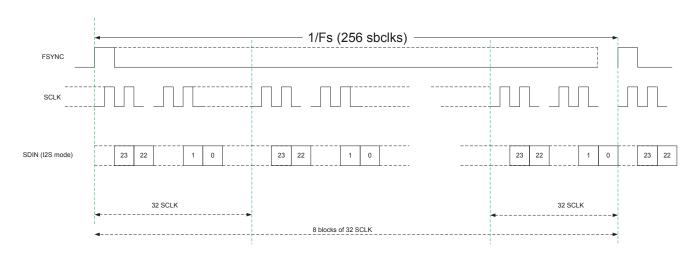


图 34. I²S Audio Data Format



Audio Data Format: TDM8 mode

图 35. TDM8 Audio Data Format

10.3.2 High-Pass Filter

Direct-current (DC) content in the audio signal can damage speakers. The data path has a high-pass filter to remove any DC from the input signal. The corner frequency is selectable from 4 Hz, 8 Hz, or 15 Hz to 30 Hz with bits 0 through 3 in register 0x26. The default value of –3 dB is approximately 4 Hz for 44.1 kHz or 48 kHz and approximately 8 Hz for 96 kHz sampling rates.

10.3.3 Volume Control and Gain

Each channel has an independent digital-volume control with a range from –100 dB to +24 dB with 0.5-dB steps. The volume control is set through I²C. The gain-ramp rate is programmable through I²C to take one step every 1, 2, 4, or 8 FSYNC cycles.

The peak output-voltage swing is also configurable in the gain control register through I²C. The four gain settings are 7.5 V, 15 V, 21 V, and 29 V. TI recommends selecting the lowest possible for the expected PVDD operation to optimize output noise and dynamic range performance.

10.3.4 High-Frequency Pulse-Width Modulator (PWM)

The PWM converts the PCM input data into a switched signal of varying duty cycle. The PWM modulator is an advanced design with high bandwidth, low noise, low distortion, and excellent stability. The output switching rate is synchronous to the serial audio-clock input and is programmed through I²C to be between 8x and 48x the input-sample rate. The option to switch at high frequency allows the use of smaller and lower cost external filtering components. 表 3 lists the switch frequency options for bits 4 through 6 in the Miscellaneous Control 2 Register (address 0x02).

INPUT SAMPLE RATE		BIT 6:4 SETTINGS								
	000	001	010 to 100	101	110	111				
44.1 kHz	352.8 kHz	441 kHz	RESERVED	1.68 MHz	1.94 MHz	2.12 MHz				
48 kHz	384 kHz	480 kHz	RESERVED	1.82 MHz	2.11 MHz	Not supported				
96 kHz	384 kHz	480 kHz	RESERVED	1.82 MHz	2.11 MHz	Not supported				

表 3. Output Switch Frequency Option

10.3.5 Gate Drive

The gate driver accepts the low-voltage PWM signal and level shifts it to drive a high-current, full-bridge, power-FET stage. The device uses proprietary techniques to optimize EMI and audio performance.

The gate-driver power-supply voltage, GVDD, is internally generated and a decoupling capacitor is connected at pin 9 and pin 10.

The full H-bridge output stages use only NMOS transistors. Therefore, bootstrap capacitors are required for the proper operation of the high side NMOS transistors. A 1-μF ceramic capacitor of quality X7R or better, rated for at least 16 V, must be connected from each output to the corresponding bootstrap input (see the application circuit diagram in 279). The bootstrap capacitors connected between the BST pins and corresponding output function as a floating power supply for the high-side N-channel power MOSFET gate drive circuitry. During each high-side switching cycle, the bootstrap capacitors hold the gate-to-source voltage high keeping the high-side MOSFETs turned on.

10.3.6 Power FETs

The BTL output for each channel comprises four N-channel $90\text{-m}\Omega$ FETs for high efficiency and maximum power transfer to the load. These FETs are designed to handle the fast switching frequency and large voltage transients during load dump.

10.3.7 Load Diagnostics

The device incorporates both DC-load and AC-load diagnostics, which are used to determine the status of the load. The DC diagnostics are turned on by default, but if a fast startup without diagnostics is required, the DC diagnostics can be bypassed through I²C. The DC diagnostics runs when any channel is directed to leave the Hi-Z state and enter the MUTE or PLAY state. The DC diagnostics can also be enabled manually to run on any or all channels. DC Diagnostics can be started from any operating condition, but if the channel is in PLAY state, then the time to complete the diagnostic is longer because the device must ramp down the audio signal of that channel before transitioning to the Hi-Z state. The DC diagnostics are available as soon as the device supplies are within the recommended operating range. The DC diagnostics do not rely on the audio input clocks to be available to function. DC Diagnostic results are reported for each channel separately through the I²C registers.



10.3.7.1 DC Load Diagnostics

The DC load diagnostics are used to verify the load connected. The DC diagnostics consists of four tests: short-to-power (S2P), short-to-ground (S2G), open-load (OL), and shorted-load (SL). The S2P and S2G tests trigger if the impedance to GND or a power rail is below that specified in the *Specifications* section. The diagnostic detects a short to vehicle battery, even when the supply is boosted. The SL test has an I²C-configurable threshold depending on the expected load to be connected. Because the speakers connected to each channel might be different, each channel can be assigned a unique threshold value. The OL test reports if the select channel has a load impedance greater than the limits in the *Specifications* section.

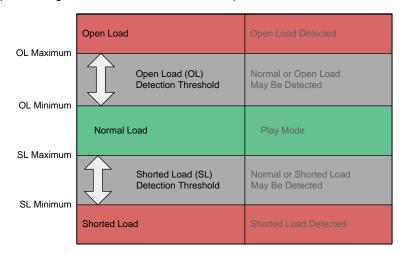


图 36. DC Load Diagnostic Reporting Thresholds

10.3.7.2 Line Output Diagnostics

The device also includes an optional test to detect a line-output load. A line-output load is a high-impedance load that is above the open-load (OL) threshold such that the DC-load diagnostics report an OL condition. After an OL condition is detected on a channel, if the line output detection bit is also set, the channel checks if a line-output load is present as well. This test is not pop free, so if an external amplifier is connected it should be muted.

10.3.7.3 AC Load Diagnostics

The AC load diagnostic is used to determine the proper connection of a capacitively-coupled speaker or tweeter when used with a passive crossover. The AC load diagnostic is controlled through I²C. The AC diagnostics requires an external input signal and reports the approximate load impedance and phase. The selected signal frequency should create current flow through the desired speaker for proper detection. If multiple channels must be tested, the diagnostics should be run in series. The AC load-diagnostic test procedure is as follows.

10.3.7.3.1 Impedance Magnitude Measurement

For load-impedance detection, use the following test procedure:

- 1. Set the channels to be tested into the Hi-Z state.
- 2. Set the AC_DIAGS_LOOPBACK bit (bit 7 in register 0x16) to 0.
- 3. Apply a full-scale input signal from the DSP for the tested channels with the desired frequency (recommended 10 kHz to 20 kHz).

The device ramps the signal up and down automatically to prevent pops and clicks.

- 4. Set the device into the AC diagnostic mode (set bit 3 through bit 0 as needed in register 0x15 to 1 for CH1 to CH4. (For PBTL mode, test channel 1 for PBTL12 and channel 3 for PBTL34))
- 5. Read back the AC impedance (register 0x17 through register 0x1A).

When the test is complete the channel reporting register indicates the status change from the AC diagnostic mode to the Hi-Z state. The detected impedance is stored in the appropriate I²C register.

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The hexadecimal register value must be converted to decimal and used to calculate the impedance magnitude using the following equation:

Channelx Impedance =
$$\frac{Impedance _CHx \times 2.371mV}{(Gain)(I \ mA)} \ (Ohms)$$

图 37. AC Magnitude Calculation

10.3.7.3.2 Impedance Phase Reference Measurement

The first stage to determine the AC phase is to utilize the built-in loopback mode to determine the reference value for the phase measurement. This reference will nullify any phase offset in the device and measure only the phase of the load. This is measured for channels 1 and 3 only. Channel 2 will use the results of channel 1 for the calculations. Channel 4 will use the results of channel 3 for the calculations. Measure channel 1 and channel 3 sequentially, they cannot be measured at the same time.

For loopback delay detection, use the following test procedure for either BTL mode or PBTL mode:

- BTL mode
 - 1. Set the AC DIAGS LOOPBACK bit (bit 7 in register 0x16) to 1 to enable AC loopback mode.
 - 2. Apply a 0-dBFS 19 kHz signal and enable AC load diagnostics. CH1 and CH2 reuse the AC sensing loop of CH1 (set bit 3 in register 0x15 to 1). CH3, CH4 reuse the AC sensing loop of CH3 (set bit 1 in register 0x15 to 1).
 - 3. Read back the 16bit hexadecimal, AC_LDG_PHASE1 value. Register 0x1B holds the MSB and register 0x1C holds the LSB.
 - 4. For channel 1/2 set bit 3 in register 0x15 to 0. For channel 3/4 set bit 1 in register 0x15 to 0.
- PBTL mode
 - 1. Set the AC DIAGS LOOPBACK bit (bit 7 in register 0x16) to 1 to enable AC loopback mode.
 - 2. Set the PBTL CH12 and PBTL CH34 bits (see register 0x00) to 0 without toggling SDz pin to enter BTL mode only for load diagnostics.
 - 3. Apply a 0 dBFS 19 kHz signal and enable AC load diagnostics. For PBTL 12, enable the AC sensing loop of CH1 (set bit 3 in register 0x15 to 1). For PBTL 34, enable the AC sensing loop of CH3 (set bit 1 in register 0x15 to 1).
 - 4. Read back the AC LDG PHASE1 value. Register 0x1B holds the MSB and register 0x1C holds the LSB.
 - 5. Set the PBTL CH12 and PBTL CH34 bits (see register 0x00) to 1 to go back to PBTL mode for load diagnostics.
 - 6. For PBTL 12 set bit 3 in register 0x15 to 0. For PBTL 34 set bit 1 in register 0x15 to 0.

When the test is complete, the channel reporting register indicates the status change from the AC diagnostic mode to the Hi-Z state. The detected impedance is stored in the appropriate I²C register.

10.3.7.3.3 Impedance Phase Measurement

After performing the phase reference measurements, measure the phase of the speaker load. This is performed in the same manner as the reference measurements, except the loopback is disabled in bit 7 register 0x16. Previously, the phase reference is measured on channel 1 and channel 3. In this test stage all four channels will be measured. Measure the channels sequentially as they cannot be measured at the same time.

For loopback delay detection, use the following test procedure for either BTL mode or PBTL mode:

- BTL mode
 - 1. Set the AC_DIAGS_LOOPBACK bit (bit 7 in register 0x16) to 0 to disable AC loopback mode.
 - 2. Apply a 0-dBFS 19 kHz signal and enable AC load diagnostics. CH1 and CH2 reuse the AC sensing loop of CH1 (set bit 3 in register 0x15 to 1). CH3, CH4 reuse the AC sensing loop of CH3 (set bit 1 in register 0x15 to 1).
 - 3. Read back the 16bit hexadecimal, AC_LDG_PHASE1 value. Register 0x1B holds the MSB and register 0x1C holds the LSB.
 - 4. Read back the hexadecimal stimulus value, STI. Register 0x1D holds the MSB and register 0x1E holds

the LSB.

5. For channel 1/2 set bit 3 in register 0x15 to 0. For channel 3/4 set bit 1 in register 0x15 to 0.

When the test is complete, the channel reporting register indicates the status change from the AC diagnostic mode to the Hi-Z state. The detected impedance is stored in the appropriate I²C register.

PBTL mode

- 1. Set the AC_DIAGS_LOOPBACK bit (bit 7 in register 0x16) to 0 to disable AC loopback mode.
- 2. Set the PBTL CH12 and PBTL CH34 bits (see register 0x00) to 0 without toggling SDz pin to enter BTL mode only for load diagnostics.
- 3. Apply a 0 dBFS 19 kHz signal and enable AC load diagnostics. For PBTL_12, enable the AC sensing loop of CH1 (set bit 3 in register 0x15 to 1). For PBTL_34, enable the AC sensing loop of CH3 (set bit 1 in register 0x15 to 1).
- 4. Read back the AC LDG PHASE1 value. Register 0x1B holds the MSB and register 0x1C holds the LSB.
- 5. Read back the hexadecimal stimulus value, STI. Register 0x1D holds the MSB and register 0x1E holds the LSB
- 6. Set the PBTL CH12 and PBTL CH34 bits (see register 0x00) to 1 to go back to PBTL mode for load diagnostics.
- 7. For PBTL_12 set bit 3 in register 0x15 to 0. For PBTL_34 set bit 1 in register 0x15 to 0.

The AC phase in degrees is calculated with the following equation:

$$Phase_CHx = 360(\frac{Phase_CHx(LBK) - Phase_CHx(LDM)}{STI_CHx(LDM)})$$

图 38. AC Phase Calculation

Where:

- Phase_CHx(LBK) is the reference phase measurement. LBK stands for loopback mode
- Phase CHx(LDM) is the phase measure of the load. LDM stands for load mode
- STI CHx(LDM) is the stimulus value

表 4. AC Impedance Code to Magnitude

SETTING	GAIN AT 19 kHz	I(A)	MEASUREMENT RANGE (Ω)	MAPPING FROM CODE TO MAGNITUDE (Ω/Code)
Gain = 4, I = 10 mA (recommended)	4.28	0.01	12	0.05832
Gain = 4, I = 19 mA	4.28	0.019	6	0.0307
Gain = 1, I = 10 mA (recommended)	1	0.01	48	0.2496
Gain = 1, I = 19 mA	1	0.019	24	0.1314

10.3.8 Protection and Monitoring

10.3.8.1 Overcurrent Limit (I, IMIT)

The overcurrent limit terminates each PWM pulse to limit the output current flow when the current limit (I_{LIMIT}) is exceeded. Power is limited, but operation continues without disruption and prevents undesired shutdown for transient music events. I_{LIMIT} is not reported as a fault condition to either registers or the FAULT pin. Each channel is independently monitored and limited. The two programable levels can be set by bit 4 in the Miscellaneous Control 1 register (address 0x01).

10.3.8.2 Overcurrent Shutdown (I_{SD})

If the output load current reaches I_{SD}, such as an output short to GND, then a peak current limit occurs, which shuts down the channel. The time to shutdown the channel varies depending on the severity of the short condition. The affected channel is placed into the Hi-Z state, the fault is reported to the register, and the FAULT pin is asserted. The device will remain in this state until the CLEAR FAULT bit is set in Miscellaneous Control 3 Register, 0x21 bit 7. After clearing this bit and if the diagnostics are enabled, the device will automatically start diagnostics on the channel and, if no load failure is found, the device will restart. If a load fault is found the device continues to rerun the diagnostics once per second. Because this hiccup mode uses the diagnostics, no high current is created. If the diagnostics are disabled, the device sets the state for that channel to Hi-Z and requires the MCU to take the appropriate action, setting the CLEAR FAULT bit after the fault got removed, in order to return to Play state.

Two programable levels can be set by bit 4 in the Miscellaneous Control 1 register (address 0x01).

10.3.8.3 DC Detect

This circuit detects a DC offset continuously during normal operation at the output of the amplifier. If the DC offset exceeds the threshold, that channel is placed in the Hi-Z state, the fault is reported to the I²C register, and the FAULT pin is asserted. A register bit can be used to mask reporting to the FAULT pin if required.

10.3.8.4 Clip Detect

The clip detect is reported on the WARN pin if 100% duty-cycle PWM is reached for a minimum number of PWM cycles set by the Clip Wndow Register (address 0x23). The default is 20 PWM cycles, If any channel is clipping. the clipping is reported to the pin. The clip detect is latched and can be cleared by I2C. Masking the clip reporting to the pin is possible through I²C.

10.3.8.5 Global Overtemperature Warning (OTW), Overtemperature Shutdown (OTSD)

Four overtemperature warning levels are available in the device (see the *Register Maps* section for thresholds). When the junction temperature exceeds the warning level, the WARN pin is asserted, unless the mask bit has been set to disable reporting. The device functions until the OTSD value is reached at which point all channels are placed in the Hi-Z state, and the FAULT pin is asserted. When the junction temperature returns to normal levels, the device automatically recovers and places all channels into the state indicated by the register settings.

10.3.8.6 Channel Overtemperature Warning [OTW(i)] and Shutdown [OTSD(i)]

In addition to the global OTW, each channel also has an individual overtemperature warning and shutdown. If a channel exceeds the OTW(i) threshold, the warning register bit is set as the WARN pin is asserted, unless the mask bit has been set to disable reporting. If the channel temperature exceeds the OTSD(i) threshold then that channel goes to the Hi-Z state until the temperature drops below the OTW(i) threshold. At this point, the channel goes to the state indicated by the state control register.

10.3.8.7 Undervoltage (UV) and Power-On-Reset (POR)

The undervoltage (UV) protection detects low voltages on the PVDD and VBAT pins. In the event of an UV condition, the FAULT pin is asserted, and the I²C register is updated. A power-on reset (POR) on the VDD pin causes the I²C to goes to the high-impedance (Hi-Z) state, and all registers are reset to default values. At poweron or after a POR event, the POR warning bit and WARN pin are asserted.

10.3.8.8 Overvoltage (OV) and Load Dump

The overvoltage (OV) protection detects high voltages on the PVDD pin. If the PVDD pin reaches the OV threshold, the FAULT pin is asserted and the I²C register is updated. The device can withstand 40 V load-dump voltage spikes.

10.3.9 Power Supply

The device has three power supply inputs, VDD, PVDD, and VBAT, which are described as follows:

VDD This pin is a 3.3V supply pin that provides power to the low voltage circuitry.

VBAT This pin is a higher voltage supply that can be connected to the vehicle battery or the regulated voltage rail in a boosted system within the recommended limits. For best performance, this rail

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should be 10 V or higher. See the *Recommended Operating Conditions* table for the maximum supply voltage. This supply rail is used for higher voltage analog circuits but not the output FETs.

PVDD

This pin is a high-voltage supply that can either be connected to the vehicle battery or to another voltage rail in a boosted system. The PVDD pin supplies the power to the output FETs and can be within the recommended operating limits, even if that is below the VBAT supply, to allow for dynamic voltage systems.

Several on-chip regulators are included for generating the voltages necessary for the internal circuitry. The external pins are provided only for bypass capacitors to filter the supply and should not be used to power other circuits.

The device can withstand fortuitous open ground and power conditions within the absolute maximum ratings for the device. Fortuitous open ground usually occurs when a speaker wire is shorted to ground, allowing for a second ground path through the body diode in the output FETs.

10.3.9.1 Vehicle-Battery Power-Supply Sequence

Power-Up Sequence

In a typical system, the VBAT and PVDD supplies are both connected to the vehicle battery and power up at the same time. The VDD supply is recommended to be applied 200µs before the VBAT and PVDD supplies start ramping to their recommended operating range. As reference, please see 39. If this is unfeasible and VBAT / PVDD will be supplied before VDD, it is recommended wait 200µs after VDD is supplied before pulling the STANDBY pin high. As reference, please see 40.

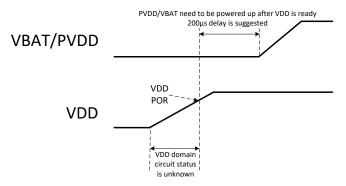


图 39. Power-Up Sequence Option 1

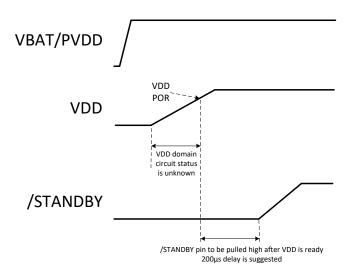


图 40. Power-Up Sequence Option 2

Power-Down Sequence

When removing power from the device, TI recommends to deassert the VBAT and PVDD supplies together first, which provides the lowest click and pop performance, and VDD last. During powering down, VDD must remain available for at least 1.01s after all output stages got set to Hi-Z. To shorten this required delay to 46ms, a 20kOhm parallel resistor between AVDD and AVSS can be added.

10.3.9.2 Boosted Power-Supply Sequence

In this scenario, the VBAT and PVDD inputs are not connected to the same supply. During power-up, PVDD should be supplied last while during power-down PVDD should be removed first. All other recommendation apply as described in Vehicle-Battery Power-Supply Sequence.

10.3.10 Hardware Control Pins

The device has four pins for control and device status: FAULT, MUTE, WARN, and STANDBY.

10.3.10.1 FAULT

The FAULT pin reports faults and is active low under any of the following conditions:

- Any channel faults (overcurrent or DC detection)
- Overtemperature shutdown
- · Overvoltage or undervoltage conditions on the VBAT or PVDD pins
- Clock errors

The FAULT pin is deactivated when none of the previously listed conditions exist.

Register bits are available to mask fault categories from reporting to the FAULT pin. These bits only mask the setting of the pin and do not affect the register reporting or protection of the device. By default all faults are reported to the pin. See the *Register Maps* section for a description of the mask settings.

This pin is an open-drain output with an internal 100 k Ω pullup resistor to VDD.

10.3.10.2 WARN

This active-low output pin reports audio clipping, overtemperature warnings, and POR events.

Clipping is reported if any channel is at the maximum modulation for 20 consecutive PWM clocks which results in a 10-µs delay to report the onset of clipping. The warning bit is sticky and can be cleared by the CLEAR FAULT bit (bit 7) in register 0x21.

An overtemperature warning (OTW) is reported if the general temperature or any of the channel temperature warnings are set. The warning temperature can be set through bits 5 and 6 in register 0x01.

Register bits are available to mask either clipping or OTW reporting to the pin. These bits only mask the setting of the pin and do not affect the register reporting. By default both clipping and OTW are reported.

The WARN pin is latched and can be cleared by writing the CLEAR FAULT bit (bit 7) in register 0x21.

This pin is an open-drain output with an internal 100 k Ω pullup resistor to VDD.

10.3.10.3 **MUTE**

This active-low input pin is used for hardware control of the mute and unmute function for all channels.

This pin has a 100 $k\Omega$ internal pulldown resistor.

10.3.10.4 STANDBY

When this active-low input pin is asserted, the device goes into shutdown and current draw is limited. This pin can be used to shut down the device rapidly. The outputs are ramped down in less than 5 ms if the device is not already in the Hi-Z state.

This pin has a 100 k Ω internal pulldown resistor.

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10.4 Device Functional Modes

10.4.1 Operating Modes and Faults

The operating modes and faults are listed in the following tables.

表 5. Operating Modes

STATE NAME	OUTPUT FETS	OSCILLATOR	I ² C
STANDBY	Hi-Z	Stopped	Active
Hi-Z	Hi-Z	Active	Active
MUTE	Switching at 50%	Active	Active
PLAY	Switching with audio	Active	Active

表 6. Global Faults and Actions

FAULT/ EVENT	FAULT/EVENT CATEGORY	MONITORING MODES	REPORTING METHOD	ACTION RESULT
POR	Voltage fault	All	$I^2C + \overline{WARN}$ pin	Standby
VBAT UV				
PVDD UV		Hi-Z, mute, normal	I ² C + FAULT pin	Hi-Z
VBAT or PVDD OV				
OTW	Thermal warning	Hi-Z, mute, normal	I ² C + WARN pin	None
OTSD	Thermal shutdown	Hi-Z, mute, normal	I ² C + FAULT pin	Hi-Z

表 7. Channel Faults and Actions

FAULT/ EVENT	FAULT/EVENT CATEGORY	MONITORING MODES	REPORTING METHOD	ACTION TYPE
Clipping	Warning		WADN sis	None
Overcurrent limiting	Protection	Mosta and place	WARN pin	Current limit
Overcurrent fault	Output abannal fault	Mute and play	I2C + FALLE nin	11: 7
DC detect	Output channel fault		I ² C + FAULT pin	Hi-Z

10.5 Programming

10.5.1 I²C Serial Communication Bus

The device communicates with the system processor through the I²C serial communication bus as an I²C slaveonly device. The processor can poll the device through I²C to determine the operating status, configure settings, or run diagnostics. For a complete list and description of all I²C controls, see the *Register Maps* section.

The device includes two I^2C address pins, so up to four devices can be used together in a system with no additional bus switching hardware. The I^2C ADDRx pins set the slave address of the device as listed in $\frac{1}{8}$ 8.

	2011 0 11441100000							
DESCRIPTION	I ² C ADDR1	I ² C ADDR0	I ² C Write	I ² C Read				
Device 0	0	0	0xD4	0xD5				
Device 1	0	1	0xD6	0xD7				
Device 2	1	0	0xD8	0xD9				
Device 3	1	1	0xDA	0xDB				

表 8. I²C Addresses

10.5.2 I²C Bus Protocol

The device has a bidirectional serial-control interface that is compatible with the Inter IC (I²C) bus protocol and supports 100 kbps and 400 kbps data transfer rates for random and sequential write and read operations. The TAS6424M-Q1 device is a slave-only device that does not support a multimaster bus environment or wait-state insertion. The control interface is used to program the registers of the device and to read device status.

The I²C bus uses two signals, SDA (data) and SCL (clock), to communicate between integrated circuits in a system. Data is transferred on the bus serially, one bit at a time. The address and data are transferred in byte (8bit) format with the most-significant bit (MSB) transferred first. In addition, each byte transferred on the bus is acknowledged by the receiving device with an acknowledge bit. Each transfer operation begins with the master device driving a start condition on the bus and ends with the master device driving a stop condition on the bus. The bus uses transitions on the data terminal (SDA) while the clock is HIGH to indicate a start and stop conditions. A HIGH-to-LOW transition on SDA indicates a start, and a LOW-to-HIGH transition indicates a stop. Normal data bit transitions must occur within the low time of the clock period. The master generates the 7-bit slave address and the read/write (R/W) bit to open communication with another device and then wait for an acknowledge condition. The device holds SDA LOW during the acknowledge-clock period to indicate an acknowledgment. When this occurs, the master transmits the next byte of the sequence. Each device is addressed by a unique 7-bit slave address plus a R/W bit (1 byte). All compatible devices share the same signals via a bidirectional bus using a wired-AND connection. An external pullup resistor must be used for the SDA and SCL signals to set the HIGH level for the bus. The number of bytes that can be transmitted between start and stop conditions is unlimited. When the last word transfers, the master generates a stop condition to release the bus.

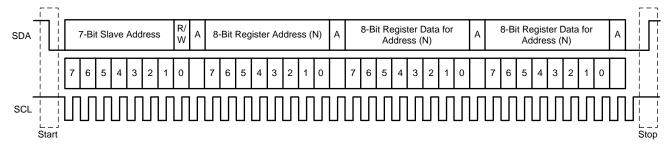
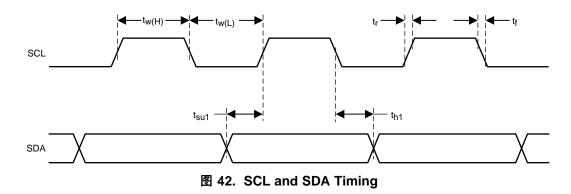


图 41. Typical I²C Sequence



Use the I²C ADDRx pins to program the device slave address. Read and write data can be transmitted using single-byte or multiple-byte data transfers.

10.5.3 Random Write

As shown in \$\mathbb{g}\$ 43, a single-byte data-write transfer begins with the master device transmitting a start condition followed by the I²C device address and the R/W bit. The R/W bit determines the direction of the data transfer. For a write data transfer, the R/W bit is a 0. After receiving the correct I²C device address and the R/W bit, the device responds with an acknowledge bit. Next, the master transmits the address byte or bytes corresponding to the internal memory address being accessed. After receiving the address byte, the device again responds with an acknowledge bit. Next, the master device transmits the data byte to be written to the memory address being accessed. After receiving the data byte, the device again responds with an acknowledge bit. Finally, the master device transmits a stop condition to complete the single-byte data-write transfer.

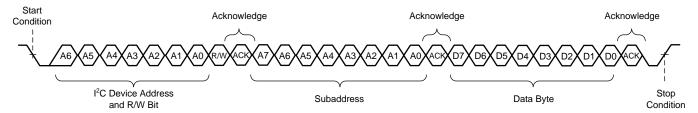


图 43. Random Write Transfer

10.5.4 Sequential Write

A sequential data-write transfer is identical to a single-byte data-write transfer except that multiple data bytes are transmitted by the master to the device as shown in $\ 24$. After receiving each data byte, the device responds with an acknowledge bit and the $\ 1^2$ C subaddress is automatically incremented by one.

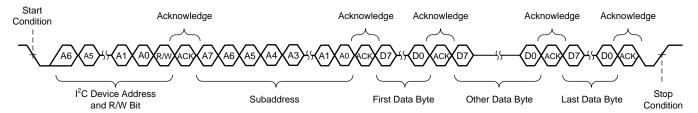


图 44. Sequential Write Transfer

10.5.5 Random Read



transmits another start condition followed by the address and the R/W bit again. This time the R/W bit is a 1, indicating a read transfer. After receiving the address and the R/W bit, the device again responds with an acknowledge bit. Next, the device transmits the data byte from the memory address being read. After receiving the data byte, the master device transmits a not-acknowledge followed by a stop condition to complete the single-byte data-read transfer.

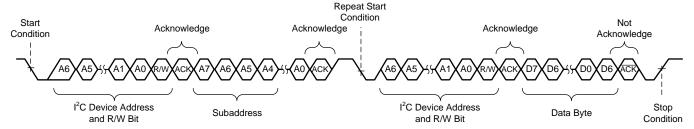


图 45. Random Read Transfer

10.5.6 Sequential Read

A sequential data-read transfer is identical to a single-byte data-read transfer except that multiple data bytes are transmitted by the device to the master device as shown in \$\mathbb{B}\$ 46. Except for the last data byte, the master device responds with an acknowledge bit after receiving each data byte and automatically increments the I²C subaddress by one. After receiving the last data byte, the master device transmits a not-acknowledge bit followed by a stop condition to complete the transfer.

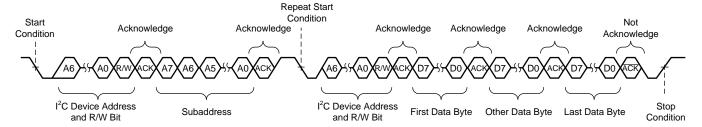


图 46. Sequential Read Transfer

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10.6 Register Maps

表 9. I²C Address Register Definitions

Address	Туре	Register Description	Section
0x00	R/W	Mode Control	Go
0x01	R/W	Miscellaneous Control 1	Go
0x02	R/W	Miscellaneous Control 2	Go
0x03	R/W	SAP Control (Serial Audio-Port Control)	Go
0x04	R/W	Channel State Control	Go
0x05	R/W	Channel 1 Volume Control	Go
0x06	R/W	Channel 2 Volume Control	Go
0x07	R/W	Channel 3 Volume Control	Go
0x08	R/W	Channel 4 Volume Control	Go
0x09	R/W	DC Diagnostic Control 1	Go
0x0A	R/W	DC Diagnostic Control 2	Go
0x0B	R/W	DC Diagnostic Control 3	Go
0x0C	R	DC Load Diagnostic Report 1 (Channels 1 and 2)	Go
0x0D	R	DC Load Diagnostic Report 2 (Channels 3 and 4)	Go
0x0E	R	DC Load Diagnostic Report 3-Line Output	Go
0x0F	R	Channel State Reporting	Go
0x10	R	Channel Faults (Overcurrent, DC Detection)	Go
0x11	R	Global Faults 1	Go
0x12	R	Global Faults 2	Go
0x13	R	Warnings	Go
0x14	R/W	Pin Control	Go
0x15	R/W	AC Load Diagnostic Control 1	Go
0x16	R/W	AC Load Diagnostic Control 2	Go
0x17	R	AC Load Diagnostic Report Channel 1	Go
0x18	R	AC Load Diagnostic Report Channel 2	Go
0x19	R	AC Load Diagnostic Report Channels 3	Go
0x1A	R	AC Load Diagnostic Report Channels 4	Go
0x1B	R	AC Load Diagnostic Phase Report High	Go
0x1C	R	AC Load Diagnostic Phase Report Low	Go
0x1D	R	AC Load Diagnostic STI Report High	Go
0x1E	R	AC Load Diagnostic STI Report Low	Go
0x1F	R	RESERVED	
0x20	R	RESERVED	
0x21	R/W	Miscellaneous Control 3	Go
0x22	R/W	Clip Control	Go
0x23	R/W	Clip Window	Go
0x24	R/W	Clip Warning	Go
0x25	R/W	ILIMIT Status	Go
0x26	R/W	Miscellaneous Control 4	Go
0x27	R	RESERVED	
0x28	R	RESERVED	



10.6.1 Mode Control Register (address = 0x00) [default = 0x00]

The Mode Control register is shown in 图 47 and described in 表 10.

图 47. Mode Control Register

7	6	5	4	3	2	1	0
RESET	RESERVED	PBTL CH34	PBTL CH12	CH1 LO MODE	CH2 LO MODE	CH3 LO MODE	CH4 LO MODE
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

表 10. Mode Control Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESET	R/W	0	O: Normal operation 1: Resets the device. Self-clearing, will read back 0.
6	RESERVED	R/W	0	RESERVED
5	PBTL CH34	R/W	0	0: Channels 3 and 4 are in BTL mode 1: Channels 3 and 4 are in parallel BTL mode
4	PBTL CH12	R/W	0	0: Channels 1 and 2 are in BTL mode 1: Channels 1 and 2 are in parallel BTL mode
3	CH1 LO MODE	R/W	0	0: Channel 1 is in normal/speaker mode 1: Channel 1 is in line output mode
2	CH2 LO MODE	R/W	0	0: Channel 2 is in normal/speaker mode 1: Channel 2 is in line output mode
1	CH3 LO MODE	R/W	0	0: Channel 3 is in normal/speaker mode 1: Channel 3 is in line output mode
0	CH4 LO MODE	R/W	0	0: Channel 4 is in normal/speaker mode 1: Channel 4 is in line output mode

10.6.2 Miscellaneous Control 1 Register (address = 0x01) [default = 0x32]

The Miscellaneous Control 1 register is shown in 图 48 and described in 表 11.

图 48. Miscellaneous Control 1 Register

7	6	5	4	3	2	1	0
HPF BYPASS	OTW CONTROL		OC CONTROL	VOLUM	ME RATE	GAIN	
R/W-0	R/W-0 R/W-01		R/W-1	R/V	N-00	R/W	/-10

表 11. Misc Control 1 Field Descriptions

Bit	Field	Туре	Reset	Description
7	HPF BYPASS	R/W	0	0: High pass filter eneabled 1: High pass filter disabled
6–5	OTW CONTROL	R/W	01	00: Global overtemperature warning set to 140°C 01: Global overtemperature warning set to 130C 10: Global overtemperature warning set to 120°C 11: Global overtemperature warning set to 110°C
4	OC CONTROL	R/W	1	0: Overcurrent is level 1 1: Overcurrent is level 2
3–2	VOLUME RATE	R/W	00	00: Volume update rate is 1 step / FSYNC 01: Volume update rate is 1 step / 2 FSYNCs 10: Volume update rate is 1 step / 4 FSYNCs 11: Volume update rate is 1 step / 8 FSYNCs

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表 11. Misc Control 1 Field Descriptions (接下页)

Bit	Field	Туре	Reset	Description
1–0	GAIN	R/W	10	00: Gain level 1 = 7.5 V peak output voltage
				01: Gain Level 2 = 15 V peak output voltage
				10: Gain Level 3 = 21 V peak output voltage
				11: Gain Level 4 = 29 V peak output voltage

10.6.3 Miscellaneous Control 2 Register (address = 0x02) [default = 0x62]

The Miscellaneous Control 2 register is shown in 图 49 and described in 表 12.

图 49. Miscellaneous Control 2 Register

7	6	5	4	3	2	1	0
RESERVED	PWM FREQUENCY			RESERVED	SDM_OSR	OUTPUT PHASE	
R/W-110					R/W-0	R/W	-10

表 12. Misc Control 2 Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED			0
6–4	PWM FREQUENCY	R/W	110	000: $8 \times f_S$ (352.8 kHz / 384 kHz) 001: $10 \times f_S$ (441 kHz / 480 kHz) 010: RESERVED 011: RESERVED 100: RESERVED 101: $38 \times f_S$ (1.68 MHz / 1.82 MHz) 110: $44 \times f_S$ (1.94 MHz / 2.11 MHz) 111: $48 \times f_S$ (2.12 MHz / not supported)
3	RESERVED		0	0
2	SDM_OSR	R/W	0	0: 64x OSR 1: 128x OSR
1–0	OUTPUT PHASE	R/W	10	00: 0 degrees output-phase switching offset 01: 30 degrees output-phase switching offset 10: 45 degrees output-phase switching offset 11: 60 degrees output-phase switching offset

10.6.4 SAP Control (Serial Audio-Port Control) Register (address = 0x03) [default = 0x04]

The SAP Control (serial audio-port control) register is shown in 图 50 and described in 表 13.

图 50. SAP Control Register

7	6	5	4	3	2	1	0
INPUT SAMP	LING RATE	8 Ch TDM SLOT SELECT	TDM SLOT SIZE	TDM SLOT SELECT 2		INPUT FORMAT	
R/W	-00	R/W-0	R/W-0	R/W-0	·	R/W-100	·

表 13. SAP Control Field Descriptions

Bit	Field	Туре	Reset	Description
7–6	INPUT SAMPLING RATE	R/W	00	00: 44.1 kHz
				01: 48 kHz
				10: 96 kHz
				11: RESERVED



表 13. SAP Control Field Descriptions (接下页)

Bit	Field	Туре	Reset	Description
5	8 Ch TDM SLOT SELECT	R/W	0	0: First four TDM slots 1: Last four TDM slots
4	TDM SLOT SIZE	R/W	0	0: TDM slot size is 24-bit or 32-bit 1: TDM slot size is 16-bit
3	TDM SLOT SELECT 2	R/W	0	0: Normal 1: swap channel 1/2 with channel 3/4
2–0	INPUT FORMAT	R/W	100	000: 24-bit right justified 001: 20-bit right justified 010: 18-bit right justified 011: 16-bit right justified 100: I ² S (16-bit or 24-bit) 101: Left justified (16-bit or 24-bit) 110: DSP mode (16-bit or 24-bit) 111: RESERVED

10.6.5 Channel State Control Register (address = 0x04) [default = 0x55]

The Channel State Control register is shown in 图 51 and described in 表 14.

图 51. Channel State Control Register

7 6	5	4	3	2	1	0
CH1 STATE CONTROL	CH2 STATE	CONTROL	RESE	RVED	RESE	RVED
R/W-01	R/W	R/W-01		<i>'</i> -01	R/W-01	

表 14. Channel State Control Field Descriptions

Bit	Field	Туре	Reset	Description
7–6	CH1 STATE CONTROL	R/W	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics
5–4	CH2 STATE CONTROL	R/W	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics
3–2	CH3 STATE CONTROL	R/W	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics
1–0	CH4 STATE CONTROL	R/W	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics

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10.6.6 Channel 1 Through 4 Volume Control Registers (address = 0x05-0x08) [default = 0xCF]

The Channel 1 Through 4 Volume Control registers are shown in 图 52 and described in 表 15.

图 52. Channel x Volume Control Register

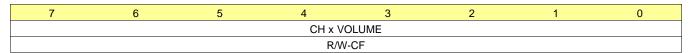


表 15. Ch x Volume Control Field Descriptions

Bit	Field	Туре	Reset	Description
7–0	CH x VOLUME	R/W	CF	8-Bit Volume Control for each channel, register address for Ch1 is 0x05, Ch2 is 0x06, Ch3 is 0x07 and Ch4 is 0x08, 0.5 dB/step: 0xFF: 24 dB
				0xCF: 0 dB
				0x07: -100 dB
				< 0x07: MUTE

10.6.7 DC Load Diagnostic Control 1 Register (address = 0x09) [default = 0x00]

The DC Diagnostic Control 1 register is shown in 图 53 and described in 表 16.

图 53. DC Load Diagnostic Control 1 Register

7	6	5	4	3	2	1	0
DC LDG ABORT	2x_RAMP	2x_SETTLE		RESERVED		LDG LO ENABLE	LDG BYPASS
R/W-0	R/W-0	R/W-0				R/W-0	R/W-0

表 16. DC Load Diagnostics Control 1 Field Descriptions

	2						
Bit	Field	Туре	Reset	Description			
7	DC LDG ABORT	R/W	0	0: Default state, clear after abort1: Aborts the load diagnostics in progress			
6	2x_RAMP	R/W	0	0: Normal ramp time 1: Double ramp time			
5	2x_SETTLE	R/W	0	0: Normal Settle time 1: Double settling time			
4–2	RESERVED		0	0			
1	LDG LO ENABLE	R/W	0	C: Line output diagnostics are disabled Line output diagnostics are enabled			
0	LDG BYPASS	R/W	0	0: Automatic diagnostics when leaving Hi-Z and after channel fault			
				1: Diagnostics are not run automatically			

10.6.8 DC Load Diagnostic Control 2 Register (address = 0x0A) [default = 0x11]

The DC Diagnostic Control 2 register is shown in 图 54 and described in 表 17.

图 54. DC Load Diagnostic Control 2 Register

7	6	5	4	3	2	1	0	
	CH1 DC	LDG SL		CH2 DC LDG SL				
	R/W-0001				R/W-	0001		



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表 17. DC Load Diagnostics Control 2 Field Descriptions

Bit	Field	Туре	Reset	Description
7–4	CH1 DC LDG SL	R/W	0001	DC load diagnostics shorted-load threshold
				0000: 0.5 Ω
				0001: 1 Ω
				0010: 1.5 Ω
				1001: 5 Ω
3–0	CH2 DC LDG SL	R/W	0001	DC load diagnostics shorted-load threshold
				0000: 0.5 Ω
				0001: 1 Ω
				0010: 1.5 Ω
				1001: 5 Ω

10.6.9 DC Load Diagnostic Control 3 Register (address = 0x0B) [default = 0x11]

The DC Diagnostic Control 3 register is shown in 图 55 and described in 表 18.

图 55. DC Load Diagnostic Control 3 Register

7	6	5	4	3	2	1	0	
	CH3 DC	LDG SL		CH4 DC LDG SL				
	R/W	-0001			R/W-	0001		

表 18. DC Load Diagnostics Control 3 Field Descriptions

Bit	Field	Туре	Reset	Description
7–4	CH3 DC LDG SL	R/W	0001	DC load diagnostics shorted-load threshold
				0000: 0.5 Ω
				0001: 1 Ω
				0010: 1.5 Ω
				1001: 5 Ω
3–0	CH4 DC LDG SL	R/W	0001	DC load diagnostics shorted-load threshold
				0000: 0.5 Ω
				0001: 1 Ω
				0010: 1.5 Ω
				1001: 5 Ω

10.6.10 DC Load Diagnostic Report 1 Register (address = 0x0C) [default = 0x00]

DC Load Diagnostic Report 1 register is shown in 图 56 and described in 表 19.

图 56. DC Load Diagnostic Report 1 Register

7	6	5	4	3	2	1	0
CH1 S2G	CH1 S2P	CH1 OL	CH1 SL	CH2 S2G	CH2 S2P	CH2 OL	CH2 SL
R-0	R-0	R-0	R-0	R-0	R-0	R-0	R-0

表 19. DC Load Diagnostics Report 1 Field Descriptions

Bit	Field	Туре	Reset	Description
7	CH1 S2G	R	0	0: No short-to-GND detected
				1: Short-To-GND Detected

表 19. DC Load Diagnostics Report 1 Field Descriptions (接下页)

		•	-	• • •
Bit	Field	Туре	Reset	Description
6	CH1 S2P	R	0	0: No short-to-power detected 1: Short-to-power detected
5	CH1 OL	R	0	0: No open load detected 1: Open load detected
4	CH1 SL	R	0	0: No shorted load detected 1: Shorted load detected
3	CH2 S2G	R	0	0: No short-to-GND detected 1: Short-to-GND detected
2	CH2 S2P	R	0	0: No short-to-power detected 1: Short-to-power detected
1	CH2 OL	R	0	0: No open load detected 1: Open load detected
0	CH2 SL	R	0	0: No shorted load detected 1: Shorted load detected

10.6.11 DC Load Diagnostic Report 2 Register (address = 0x0D) [default = 0x00]

The DC Load Diagnostic Report 2 register is shown in 图 57 and described in 表 20.

图 57. DC Load Diagnostic Report 2 Register

7	6	5	4	3	2	1	0
CH3 S2G	CH3 S2P	CH3 OL	CH3 SL	CH4 S2G	CH4 S2P	CH4 OL	CH4 SL
R-0	R-0	R-0	R-0	R-0	R-0	R-0	R-0

表 20. DC Load Diagnostics Report 2 Field Descriptions

Bit	Field	Туре	Reset	Description
7	CH3 S2G	R	0	0: No short-to-GND detected 1: Short-to-GND detected
6	CH3 S2P	R	0	0: No short-to-power detected 1: Short-to-power detected
5	CH3 OL	R	0	0: No open load detected 1: Open load detected
4	CH3 SL	R	0	0: No shorted load detected 1: Shorted load detected
3	CH4 S2G	R	0	0: No short-to-GND detected 1: Short-to-GND detected
2	CH4 S2P	R	0	0: No short-to-power detected 1: Short-to-power detected
1	CH4 OL	R	0	0: No open load detected 1: Open load detected
0	CH4 SL	R	0	0: No shorted load detected 1: Shorted load detected



10.6.12 DC Load Diagnostics Report 3 Line Output Register (address = 0x0E) [default = 0x00]

The DC Load Diagnostic Report, Line Output, register is shown in 图 58 and described in 表 21.

图 58. DC Load Diagnostics Report 3 Line Output Register



表 21. DC Load Diagnostics Report 3 Line Output Field Descriptions

Bit	Field	Туре	Reset	Description
7–4	RESERVED			0
3	CH1 LO LDG	R	0	O: No line output detected on channel 1 1: Line output detected on channel 1
2	CH2 LO LDG	R	0	No line output detected on channel 2 Line output detected on channel 2
1	CH3 LO LDG	R	0	O: No line output detected on channel 3 1: Line output detected on channel 3
0	CH4 LO LDG	R	0	No line output detected on channel 4 Line output detected on channel 4

10.6.13 Channel State Reporting Register (address = 0x0F) [default = 0x55]

The Channel State Reporting register is shown in 图 59 and described in 表 22.

图 59. Channel State-Reporting Register

7 6	3	5 4		3	2	1	0
CH1 STATE REPOR	RT C	H2 STATE REPORT	-	CH3 STATI	E REPORT	CH4 STATE	REPORT
R-01		R-01		R-	01	R-()1

表 22. State-Reporting Field Descriptions

Bit	Field	Туре	Reset	Description
7–6	CH1 STATE REPORT	R	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics
5–4	CH2 STATE REPORT	R	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics
3–2	CH3 STATE REPORT	R	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics
1–0	CH4 STATE REPORT	R	01	00: PLAY
				01: Hi-Z
				10: MUTE
				11: DC load diagnostics

10.6.14 Channel Faults (Overcurrent, DC Detection) Register (address = 0x10) [default = 0x00]

The Channel Faults (overcurrent, DC detection) register is shown in 图 60 and described in 表 23.

图 60. Channel Faults Register

7	6	5	4	3	2	1	0
CH1 OC	CH2 OC	CH3 OC	CH4 OC	CH1 DC	CH2 DC	CH3 DC	CH4 DC
R-0							

表 23. Channel Faults Field Descriptions

Bit	Field	Туре	Reset	Description
7	CH1 OC	R	0	No overcurrent fault detected Overcurrent fault detected
6	CH2 OC	R	0	0: No overcurrent fault detected 1: Overcurrent fault detected
5	СНЗ ОС	R	0	0: No overcurrent fault detected 1: Overcurrent fault detected
4	CH4 OC	R	0	0: No overcurrent fault detected 1: Overcurrent fault detected
3	CH1 DC	R	0	0: No DC fault detected 1: DC fault detected
2	CH2 DC	R	0	0: No DC fault detected 1: DC fault detected
1	CH3 DC	R	0	0: No DC fault detected 1: DC fault detected
0	CH4 DC	R	0	0: No DC fault detected 1: DC fault detected

10.6.15 Global Faults 1 Register (address = 0x11) [default = 0x00]

The Global Faults 1 register is shown in 图 61 and described in 表 24.

图 61. Global Faults 1 Register

7	6	5	4	3	2	1	0
	RESERVED		INVALID CLOCK	PVDD OV	VBAT OV	PVDD UV	VBAT UV
			R-0	R-0	R-0	R-0	R-0

表 24. Global Faults 1 Field Descriptions

Bit	Field	Туре	Reset	Description
7–5	RESERVED		0	0
4	INVALID CLOCK	R	0	0: No clock fault detected 1: Clock fault detected
3	PVDD OV	R	0	O: No PVDD overvoltage fault detected 1: PVDD overvoltage fault detected
2	VBAT OV	R	0	O: No VBAT overvoltage fault detected 1: VBAT overvoltage fault detected
1	PVDD UV	R	0	O: No PVDD undervoltage fault detected 1: PVDD undervoltage fault detected



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表 24. Global Faults 1 Field Descriptions (接下页)

Bit	Field	Туре	Reset	Description
0	VBAT UV	R	0	0: No VBAT undervoltage fault detected
				1: VBAT undervoltage fault detected

10.6.16 Global Faults 2 Register (address = 0x12) [default = 0x00]

The Global Faults 2 register is shown in 图 62 and described in 表 25.

图 62. Global Faults 2 Register

7	6	5	4	3	2	1	0
	RESERVED		OTSD	CH1 OTSD	CH2 OTSD	CH3 OTSD	CH4 OTSD
		R-0	R-0	R-0	R-0	R-0	

表 25. Global Faults 2 Field Descriptions

Bit	Field	Туре	Reset	Description
7–5	RESERVED			0
4	OTSD	R	0	No global overtemperature shutdown Global overtemperature shutdown
3	CH1 OTSD	R	0	0: No overtemperature shutdown on Ch1 1: Overtemperature shutdown on Ch1
2	CH2 OTSD	R	0	0: No overtemperature shutdown on Ch2 1: Overtemperature shutdown on Ch2
1	CH3 OTSD	R	0	0: No overtemperature shutdown on Ch3 1: Overtemperature shutdown on Ch3
0	CH4 OTSD	R	0	0: No overtemperature shutdown on Ch4 1: Overtemperature shutdown on Ch4

10.6.17 Warnings Register (address = 0x13) [default = 0x20]

The Warnings register is shown in 图 63 and described in 表 26.

图 63. Warnings Register

7	6	5	4	3	2	1	0
RESE	RVED	VDD POR	OTW	OTW CH1	OTW CH2	OTW CH3	OTW CH4
		R-0	R-0	R-0	R-0	R-0	R-0

表 26. Warnings Field Descriptions

Bit	Field	Туре	Reset	Description
7 -6	RESERVED		00	0
5	VDD POR	R	0	0: No VDD POR has occurred 1 VDD POR occurred
4	ОТЖ	R	0	No global overtemperature warning Global overtemperature warning
3	OTW CH1	R	0	No overtemperature warning on channel 1 Overtemperature warning on channel 1
2	OTW CH2	R	0	No overtemperature warning on channel 2 Overtemperature warning on channel 2

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表 26. Warnings Field Descriptions (接下页)

Bit	Field	Туре	Reset	Description
1	OTW CH3	R	0	0: No overtemperature warning on channel 3
				1: Overtemperature warning on channel 3
0	OTW CH4	R	0	0: No overtemperature warning on channel 4
				1: Overtemperature warning on channel 4

10.6.18 Pin Control Register (address = 0x14) [default = 0x00]

The Pin Control register is shown in 图 64 and described in 表 27.

图 64. Pin Control Register

7	6	5	4	3	2	1	0
MASK OC	MASK OTSD	MASK UV	MASK OV	MASK DC	MASK ILIMIT	MASK CLIP	MASK OTW
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

表 27. Pin Control Field Descriptions

Bit	Field	Туре	Reset	Description
7	MASK OC	R/W	0	0: Report overcurrent faults on the FAULT pin 1: Do not report overcurrent faults on the FAULT Pin
6	MASK OTSD	R/W	0	0: Report overtemperature faults on the FAULT pin 1: Do not report overtemperature faults on the FAULT pin
5	MASK UV	R/W	0	O: Report undervoltage faults on the FAULT pin 1: Do not report undervoltage faults on the FAULT pin
4	MASK OV	R/W	0	0: Report overvoltage faults on the FAULT pin 1: Do not report overvoltage faults on the FAULT pin
3	MASK DC	R/W	0	0: Report DC faults on the FAULT pin 1: Do not report DC faults on the FAULT pin
2	MASK ILIMIT	R/W	0	0: Report Ilimit on the FAULT pin 1: Do not report Ilimit on the FAULT pin
1	MASK CLIP	R/W	0	0: Report clipping on the WARN pin 1: Do not report clipping on the WARN pin
0	MASK OTW	R/W	0	O: Report overtemperature warnings on the WARN pin 1: Do not report overtemperature warnings on the WARN pin

10.6.19 AC Load Diagnostic Control 1 Register (address = 0x15) [default = 0x00]

The AC Load Diagnostic Control 1 register is shown in 图 65 and described in 表 28.

图 65. AC Load Diagnostic Control 1 Register

7	6	5	4	3	2	1	0
CH1/2 GAIN	RESERVED	CH3/4 GAIN	RESERVED	CH1 ENABLE	CH2 ENABLE	CH3 ENABLE	CH4 ENABLE
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

表 28. AC Load Diagnostic Control 1 Field Descriptions

Bit	Field	Туре	Reset	Description
7	CH1, CH2, PBTL12: GAIN	R/W	0	0: Gain 1
				1: Gain 4
6	RESERVED	R/W	0	0



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Bit	Field	Туре	Reset	Description
5	CH3, CH4, PBTL34: GAIN	R/W	0	0: Gain 1
				1: Gain 4
4	RESERVED	R/W	0	0
3	CH1 ENABLE	R/W	0	0: AC diagnostics disabled 1: Enable AC diagnostics
2	CH2 ENABLE	R/W	0	0: AC diagnostics disabled 1: Enable AC diagnostics
1	CH3 ENABLE	R/W	0	0: AC diagnostics disabled 1: Enable AC diagnostics
0	CH4 ENABLE	R/W	0	0: AC diagnostics disabled 1: Enable AC diagnostics

表 28. AC Load Diagnostic Control 1 Field Descriptions (接下页)

10.6.20 AC Load Diagnostic Control 2 Register (address = 0x16) [default = 0x00]

The AC Load Diagnostic Control 2 register is shown in 图 66 and described in 表 29.

图 66. AC Load Diagnostic Control 2 Register

7	6 5		4	3	3 2		0
AC_DIAGS_LO OPBACK			AC TIMING	AC CU	IRRENT	RESE	RVED
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

表 29. AC Load Diagnostic Control 2 Field Descriptions

Bit	Field	Туре	Reset	Description
7	AC_DIAGS_LOOPBACK	R/W	0	0: Disable AC Diag loopback
				1: Enable AC Diag loopback
6-5	RESERVED	R/W	00	00
4	AC TIMING	R/W	0	0: 32 Cycles
				1: 64 Cycles
3-2	AC CURRENT	R/W	00	00: 10mA
				01: 19 mA
				10: RESERVED
				11: RESERVED
1-0	RESERVED	R/W	00	00

10.6.21 AC Load Diagnostic Impedance Report Ch1 through CH4 Registers (address = 0x17–0x1A) [default = 0x00]

The AC Load Diagnostic Report Ch1 through CH4 registers are shown in 图 67 and described in 表 30.

图 67. AC Load Diagnostic Impedance Report Chx Register



表 30. Chx AC LDG Impedance Report Field Descriptions

Bit	Field	Туре	Reset	Description
7–0	CH x IMPEDANCE	R	00	8-bit AC-load diagnostic report for each channel with a step size of 0.2496 Ω /bit (control by register 0x15 and register 0x16) 0x00: 0 Ω 0x01: 0.2496 Ω
				0xFF: 63.65 Ω

10.6.22 AC Load Diagnostic Phase Report High Register (address = 0x1B) [default = 0x00]

The AC Load Diagnostic Phase High value registers are shown in 图 68 and described in 表 31.

图 68. AC Load Diagnostic (LDG) Phase High Report Register

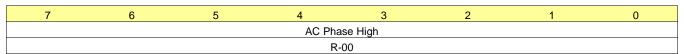


表 31. AC LDG Phase High Report Field Descriptions

Bit	Field	Туре	Reset	Description
7–0	AC Phase High	R	00	Bit 15:8

10.6.23 AC Load Diagnostic Phase Report Low Register (address = 0x1C) [default = 0x00]

The AC Load Diagnostic Phase Low value registers are shown in 图 69 and described in 表 32.

图 69. AC Load Diagnostic (LDG) Phase Low Report Register

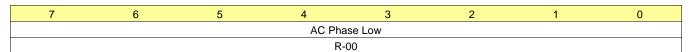


表 32. AC LDG Phase Low Report Field Descriptions

Bit	Field	Туре	Reset	Description
7–0	AC Phase Low	R	00	Bit 7:0

10.6.24 AC Load Diagnostic STI Report High Register (address = 0x1D) [default = 0x00]

The AC Load Diagnostic STI High value registers are shown in 图 70 and described in 表 33.

图 70. AC Load Diagnostic (LDG) STI High Report Register

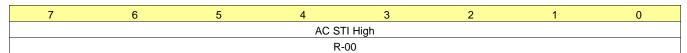


表 33. AC LDG STI High Report Field Descriptions

Bit	Field	Туре	Reset	Description
7–0	AC STI High	R	00	Bit 15:8



10.6.25 AC Load Diagnostic STI Report Low Register (address = 0x1E) [default = 0x00]

The AC Load Diagnostic STI Low value registers are shown in 图 71 and described in 表 34.

图 71. AC Load Diagnostic (LDG) STI Low Report Register

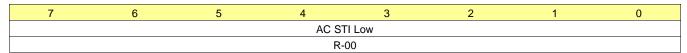


表 34. Chx AC LDG STI Low Report Field Descriptions

Bit	Field	Туре	Reset	Description
7–0	AC STI Low	R	00	Bit 7:0

10.6.26 Miscellaneous Control 3 Register (address = 0x21) [default = 0x00]

The Miscellaneous Control 3 register is shown in 图 72 and described in 表 35.

图 72. Miscellaneous Control 3 Register

7	6	5	4	3	2	1	0
CLEAR FAULT	PBTL_CH_SEL	MASK ILIMIT WARNING	RESERVED	OTSD AUTO RECOVERY		RESERVED	
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0			

表 35. Misc Control 3 Field Descriptions

Bit	Field	Туре	Reset	Description
7	CLEAR FAULT	R/W	0	0: Normal operation
				1: Clear fault
6	PBTL_CH_SEL	R/W	0	0: PBTL normal signal source
				1: PBTL flip signal source
5	MASK ILIMIT WARNING	R/W	0	0: Report ILIMIT on the WARN pin
				1: Do not report ILIMIT on the WARN pin
4	RESERVED	R/W	0	
3	OTSD AUTO RECOVERY	R/W	0	0: OTSD is latched
				1: OTSD is autorecovery
2–0	RESERVED		0	0

10.6.27 Clip Control Register (address = 0x22) [default = 0x01]

The Clip Detect register is shown in and described in $\frac{1}{2}$ 36. To ensure the Clip Detect Warning is operating according to the expectation, the related bit values in the Clip Window Register (address = 0x23) [default = 0x14] and Clip Warning Register (address = 0x24) [default = 0x00] must be set accordingly.

图 73. Clip Control Register

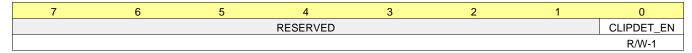


表 36. Clip Control Field Descriptions

Bit	Field	Туре	Reset	Description
0	CLIPDET_EN	R/W	1	0: Clip detect disable
				1: Clip Detect Enable

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10.6.28 Clip Window Register (address = 0x23) [default = 0x14]

The Clip Window register is shown in 图 74 and described in 表 37. The register value represents the minimum number of 100% duty-cycle PWM cycles in hexadecimal notation before Clip Detect is reported.

图 74. Clip Window Register

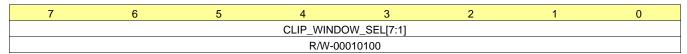


表 37. Clip Window Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	CLIP_WINDOW_SEL[7:1]	R/W	00010100	00010100: 20 100% duty-cycle PWM cycles before Clip Detect is triggered

10.6.29 Clip Warning Register (address = 0x24) [default = 0x00]

The Clip Window register is shown in 图 75 and described in 表 38.

图 75. Clip Warning Register

7	6	5	4	3	2	1	0
	RESE	RVED		CH4_CLIP	CH3_CLIP	CH2_CLIP	CH1_CLIP
				R-0	R-0	R-0	R-0

表 38. Clip Warning Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	RESERVED		0	RESERVED
3	CH4_CLIP	R	0	0: No Clip Detect 1: Clip Detect
2	CH3_CLIP	R	0	0: No Clip Detect 1: Clip Detect
1	CH2_CLIP	R	0	0: No Clip Detect 1: Clip Detect
0	CH1_CLIP	R	0	0: No Clip Detect 1: Clip Detect

10.6.30 ILIMIT Status Register (address = 0x25) [default = 0x00]

The ILIMIT Status register is shown in 图 76 and described in 表 39.

图 76. ILIMIT Status Register

7	6	5	4	3	2	1	0
	RESE	RVED		RESERVED	RESERVED	CH2_ILIMIT_W ARN	CH1_ILIMIT_W ARN
_		·	·-	R-0	R-0	R-0	R-0

表 39. ILIMIT Status Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	RESERVED		0	RESERVED
3	CH4_ILIMIT_WARN	R	0	0: No ILIMIT 1: ILIMIT Warning
2	CH3_ILIMIT_WARN	R	0	0: No ILIMIT 1: ILIMIT Warning



表 39. ILIMIT Status Field Descriptions (接下页)

Bit	Field	Туре	Reset	Description
1	CH2_ILIMIT_WARN	R	0	0: No ILIMIT
				1: ILIMIT Warning
0	CH1_ILIMIT_WARN	R	0	0: No ILIMIT
				1: ILIMIT Warning

10.6.31 Miscellaneous Control 4 Register (address = 0x26) [default = 0x40]

The Miscellaneous Control 4 register is shown in and described in 表 40.

图 77. Miscellaneous Control 4 Register

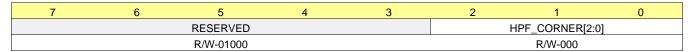


表 40. Misc Control 4 Field Descriptions

Bit	Field	Туре	Reset	Description
7-3	RESERVED	R/W	01000	01000: DEFAULT
2-0	HPF_CORNER[2:0]	R/W	000	000: 3.7 Hz
				001: 7.4 Hz
				010: 15 Hz
				011: 30 Hz
				100: 59 Hz
				101: 118 Hz
				110: 235 Hz
				111: 463 Hz

TEXAS INSTRUMENTS

11 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

11.1 Application Information

The TAS6424M-Q1 is a four-channel class-D digital-input audio-amplifier design for use in automotive head units and external amplifier modules. The TAS6424M-Q1 incorporates the necessary functionality to perform in demanding OEM applications.

11.1.1 AM-Radio Band Avoidance

AM-radio frequency interference can be avoided by setting the switching frequency of the device above the AM band. The switching frequency options available are 38 f_s , 44 f_s , and 48 f_s . If the switch frequency cannot be set above the AM band, then use the two options of 8 f_s and 10 f_s . These options should be changed to avoid AM active channels.

11.1.2 Parallel BTL Operation (PBTL)

The device can drive more current-paralleling BTL channels on the load side of the LC output filter. For parallel operation, the parallel BTL mode, PBTL, must be used and the paralleled channels must have the same state in the state control register. If the two states are not aligned the device reports a fault condition.

To set the requested channels to PBTL mode the device must be in standby mode for the commands to take effect.

A load diagnostic is supported for PBTL channels. Paralleling on the device side of the LC output filter is not supported.

11.1.3 Demodulation Filter Design

The amplifier outputs are driven by high-current LDMOS transistors in an H-bridge configuration. These transistors are either fully off or fully on. The result is a square-wave output signal with a duty cycle that is proportional to the amplitude of the audio signal. An LC demodulation filter is used to recover the audio signal. The filter attenuates the high-frequency components of the output signals that are out of the audio band. The design of the demodulation filter significantly affects the audio performance of the power amplifier. Therefore, to meet the system THD+N requirements, the selection of the inductors used in the output filter should be carefully considered.

11.1.4 Line Driver Applications

In many automotive audio applications, the same head unit must drive either a speaker (with several ohms of impedance) or an external amplifier input (with several kiloohms of impedance). The design is capable of supporting both applications and has special line-drive gain and diagnostics. Coupled with the high switching frequency, the device is well suited for this type of application. Set the desired channel in line driver mode through I²C register 0x00, the externally connected amplifier must have a differential impedance from 600 Ω to 4.7 k Ω for the DC line diagnostic to detect the connected external amplifier. \blacksquare 78 shows the recommended external amplifier input configuration.

Application Information (接下页)

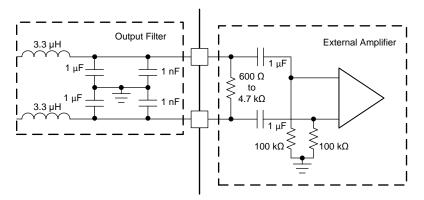


图 78. External Amplifier Input Configuration for Line Driver

TEXAS INSTRUMENTS

11.2 Typical Applications

11.2.1 BTL Application

图 79 shows the schematic of a typical 4-channel solution for a head-unit application.

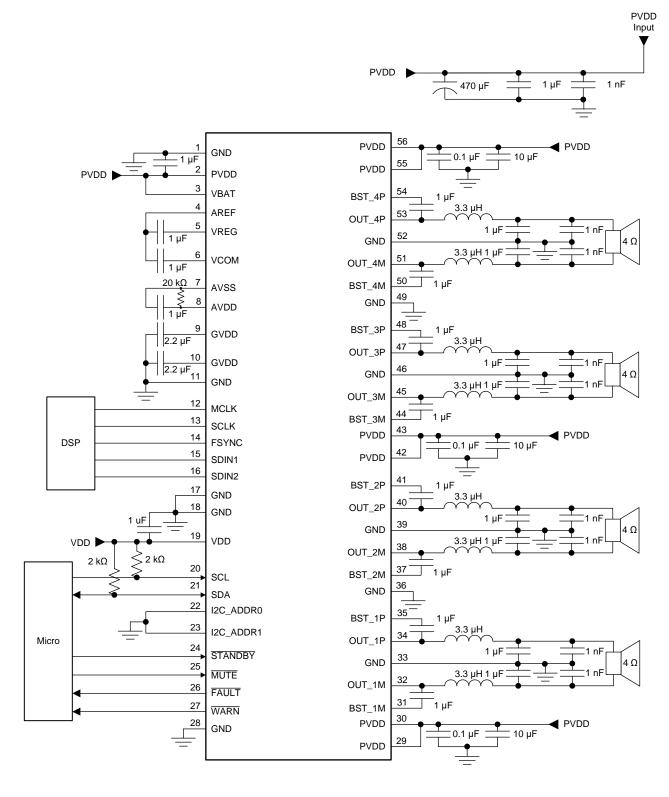


图 79. TAS6424M-Q1 Typical 4-Channel BTL Application Schematic

Typical Applications (接下页)

11.2.1.1 Design Requirements

Use the following requirements for this design:

- This head-unit example is focused on the smallest solution size for 4 x 50 W output power into 2 Ω with a battery supply of 14.4 V.
- The switching frequency is set above the AM-band with 44 times the input sample rate of 48 kHz which results in a frequency of 2.11 MHz.
- The selection of a 2.11 MHz switch frequency enables the use of a small output inductor value of 3.3 µH which leads to a very small solution size.

11.2.1.2 Communication

All communications to the TAS6424M-Q1 are through the I²C protocol. A system controller can communicate with the device through the SDA pins and SCL pins. The TAS6424M-Q1 is an I²C slave device and requires a master. The device cannot generate an I²C clock or initiate a transaction. The maximum clock speed accepted by the device is 400 kHz. If multiple TAS6424M-Q1 devices are on the same I²C bus, the I²C address must be different for each device. Up to four TAS6424M-Q1 devices can be on the same I²C bus.

The I²C bus is shared internally.



Complete any internal operations, such as load diagnostics, before reading the registers for the results.

11.2.1.3 Detailed Design Procedure

11.2.1.3.1 Hardware Design

Use the following procedure for the hardware design:

- Determine the input format. The input format can be either I²S or TDM mode. The mode determines the correct pin connections and the I²C register settings.
- Determine the power output that is required into the load. The power requirement determines the required power-supply voltage and current. The output reconstruction-filter components that are required are also driven by the output power.
- With the requirements, adjust the typical application schematic in \(\mathbb{Z} \) 79 for the input connections.

11.2.1.3.2 Digital Input and the Serial Audio Port

The TAS6424M-Q1 device supports four different digital input formats which are: I²S, Right Justified, Left Justified, and TDM mode. Depending on the format, the device can support 16, 18, 20, 24, and 32 bit data. The supported frequencies are 96 kHz, 48 kHz, and 44.1 kHz. Please see 表 13 for the I²C register, SAP Control, for the complete matrix to set up the serial audio port.

注

Bits 3, 4, and 5 in this register are ignored in all input formats except for TDM. Setting up all the control registers to the system requirements should be done before the device is placed in Mute mode or Play mode. After the registers are setup, use bit 7 in register 0x21 to clear any faults. Then read the fault registers to make sure no faults are present. When no faults are present, use register 0x04 to place the device properly into play mode.

11.2.1.3.3 Bootstrap Capacitors

The bootstrap capacitors provide the gate-drive voltage of the upper N-channel FET. These capacitors must be sized appropriately for the system specification. A special condition can occur where the bootstrap may sag if the capacitor is not sized accordingly. The special condition is just below clipping where the PWM is slightly less than 100% duty cycle with sustained low-frequency signals. Changing the bootstrap capacitor value to 2.2 µF for driving subwoofers that require frequencies below 30 Hz may be necessary.

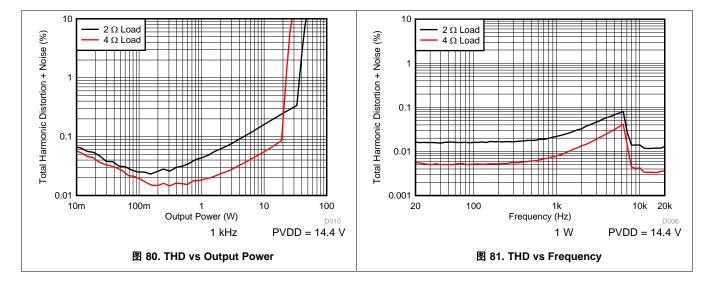
TEXAS INSTRUMENTS

Typical Applications (接下页)

11.2.1.3.4 Output Reconstruction Filter

The output FETs drive the amplifier outputs in an H-Bridge configuration. These transistors are either fully off or fully on. The result is a square-wave output signal with a duty cycle that is proportional to the amplitude of the audio signal. The amplifier outputs require a reconstruction filter that comprises a series inductor and a capacitor to ground on each output, generally called an LC filter. The LC filter attenuates the PWM frequency and reduces electromagnetic emissions, allowing the reconstructed audio signal to pass to the speakers. refer to the *Class-D LC Filter Design*, (SLOA119) for a detailed description of proper component description and design of the LC filter based upon the specified load and frequency response. The recommended low-pass cutoff frequency of the LC filter is dependent on the selected switching frequency. The low-pass cutoff frequency can be as high as 100 kHz for a PWM frequency of 2.1 MHz. At a PWM frequency of 384 kHz the low-pass cutoff frequency should be less than 40 kHz. Certain specifications must be understood for a proper inductor. The inductance value is given at zero current, but the TAS6424M-Q1 device will have current. Use the inductance versus current curve for the inductor to make sure the inductance does not drop below 1 μ H (for $f_{SW} = 2.1$ MHz) at the maximum current provided by the system design. The DCR of the inductor directly affects the output power of the system design. The lower the DCR, the more power is provided to the speakers. The typical inductor DCR for a 4 Ω system is 40 to 50 m Ω and for a 2 Ω system is 20 to 25 m Ω .

11.2.1.4 Application Curves



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Typical Applications (接下页)

11.2.2 PBTL Application

图 82 shows a schematic of a typical 2-channel solution for a head unit or external amplifier application where high power into 2 Ω is required.

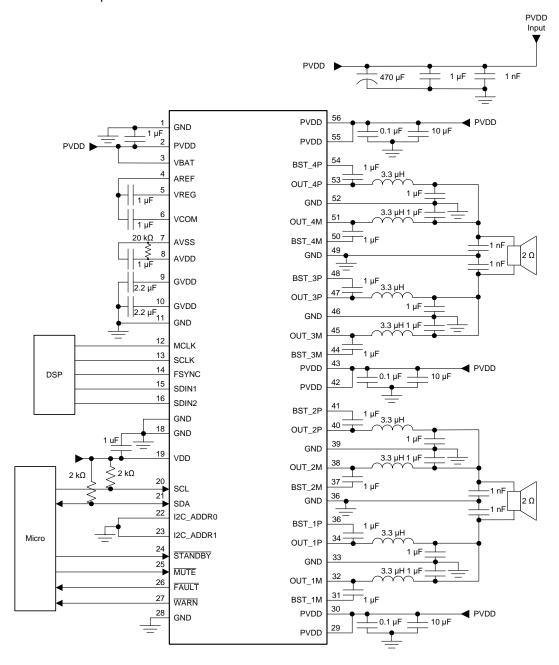


图 82. TAS6424M-Q1 Typical 2-Channel PBTL Application Schematic

To operate in PBTL mode the output stage must be paralleled according to the schematic in 图 82. The device can operate in a mix of PBTL and BTL mode. This application can be set up for 3-channels, with one channel in PBTL mode and two channels in BTL mode. The device does not support a parallel configuration of all four channels for a one channel amplifier.

Typical Applications (接下页)

11.2.2.1 Design Requirements

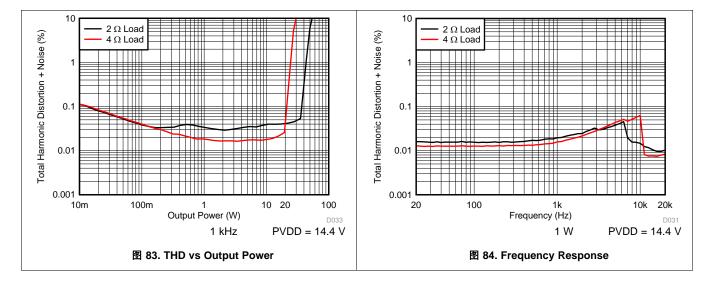
Use the following requirements for this design:

- This head-unit example is focused on the smallest solution size for 2 x 50 W output power into 2 Ω with a battery supply of 14.4 V.
- The switching frequency is set above the AM-band with 44 times the input sample rate of 48 kHz which
 results in a frequency of 2.11 MHz.
- The selection of a 2.11 MHz switch frequency enables the use of a small output inductor value of 3.3 μH which leads to a very small solution size.

11.2.2.1.1 Detailed Design Procedure

As a starting point, refer to the *Detailed Design Procedure* section for the BTL application. PBTL mode requires schematic changes in the output stage as shown in 82. The other required changes include setting up the 1^2 C registers correctly (see 313) and selecting which frame or channel to use on each output. Bit 6 in register 0x21 controls the frame selection.

11.2.2.2 Application Curves



12 Power Supply Recommendations

The TAS6424M-Q1 requires three power supplies. The PVDD supply is the high-current supply in the recommended supply range. The VBAT supply is lower current supply that must be in the recommended supply range. The PVDD and VBAT pins can be connected to the same supply if the recommended supply range for VBAT is maintained. The VDD supply is the 3.3 Vdc logic supply and must be maintained in the tolerance as shown in the *Recommended Operating Conditions* table.

13 Layout

13.1 Layout Guidelines

The pinout of the TAS6424M-Q1 was selected to provide flowthrough layout with all high-power connections on the right side, and all low-power signals and supply decoupling on the left side.

图 85 shows the area for the components in the application example (see the *Typical Applications* section).

The TAS6424M-Q1 EVM uses a four-layer PCB. The copper thickness was selected as 70 µm to optimize power loss.

The small value of the output filter provides a small size and, in this case, the low height of the inductor enables double-sided mounting.

The EVM PCB shown in 88 85 is the basis for the layout guidelines.

13.1.1 Electrical Connection of Thermal pad and Heat Sink

For the DKQ package, the heat sink connected to the thermal pad of the device should be connected to GND. The heat slug must not be connected to any other electrical node.

13.1.2 EMI Considerations

Automotive-level EMI performance depends on both careful integrated circuit design and good system-level design. Controlling sources of electromagnetic interference (EMI) was a major consideration in all aspects of the design. The design has minimal parasitic inductances because of the short leads on the package which reduces the EMI that results from current passing from the die to the system PCB. Each channel also operates at a different phase. The design also incorporates circuitry that optimizes output transitions that cause EMI.

For optimizing the EMI a solid ground layer plane is recommended, for a PCB design the fulfills the CISPR25 level 5 requirements, see the TAS6424M-Q1 EVM layout.

13.1.3 General Guidelines

The EVM layout is optimized for low noise and EMC performance.

The TAS6424M-Q1 has an exposed thermal pad that is up, away from the PCB. The layout must consider an external heat sink.

Refer to **85** for the following guidelines:

- A ground plane, A, on the same side as the device pins helps reduce EMI by providing a very-low loop impedance for the high-frequency switching current.
- The decoupling capacitors on PVDD, B, are very close to the device with the ground return close to the ground pins.
- The ground connections for the capacitors in the LC filter, *C*, have a direct path back to the device and also the ground return for each channel is the shared. This direct path allows for improved common mode EMI rejection.
- The traces from the output pins to the inductors, *D*, should have the shortest trace possible to allow for the smallest loop of large switching currents.
- Heat-sink mounting screws, E, should be close to the device to keep the loop short from the package to ground.
- Many vias, F, stitching together the ground planes can create a shield to isolate the amplifier and power supply.

13.2 Layout Example

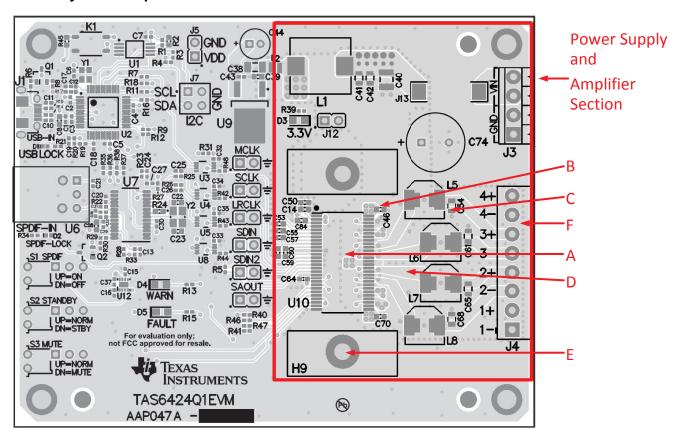


图 85. EVM Layout

13.3 Thermal Considerations

The thermally enhanced PowerPAD package has an exposed pad up for connection to a heat sink. The output power of any amplifier is determined by the thermal performance of the amplifier as well as limitations placed on it by the system, such as the ambient operating temperature. The heat sink absorbs heat from the TAS6424M-Q1 and transfers it to the air. With proper thermal management this process can reach equilibrium and heat can be continually transferred from the device. Heat sinks can be smaller than that of classic linear amplifier design because of the excellent efficiency of class-D amplifiers. This device is intended for use with a heat sink, therefore, $R_{\theta JC}$ will be used as the thermal resistance from junction to the exposed metal package. This resistance will dominate the thermal management, so other thermal transfers will not be considered. The thermal resistance of $R_{\theta JA}$ (junction to ambient) is required to determine the full thermal solution. The thermal resistance is comprised of the following components:

- R_{e,IC} of the TAS6424M-Q1
- · Thermal resistance of the thermal interface material
- Thermal resistance of the heat sink

The thermal resistance of the thermal interface material can be determined from the manufacturer's value for the area thermal resistance (expressed in °Cmm²/W) and the area of the exposed metal package. For example, a typical, white, thermal grease with a 0.0254 mm (0.001 inch) thick layer is approximately 4.52°C mm²/W. The TAS6424M-Q1 in the DKQ package has an exposed area of 47.6 mm². By dividing the area thermal resistance by the exposed metal area determines the thermal resistance for the thermal grease. The thermal resistance of the thermal grease is 0.094°C/W

表 41 lists the modeling parameters for one device on a heat sink. The junction temperature is assumed to be 115°C while delivering and average power of 10 watts per channel into a 4 Ω load. The thermal-grease example previously described is used for the thermal interface material. Use 公式 1 to design the thermal system.

(1)



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Thermal Considerations (接下页)

 $R_{\theta JA} = R_{\theta JC}$ + thermal interface resistance + heat sink resistance

表 41. Thermal Modeling

Description	Value
Ambient Temperature	25°C
Average Power to load	40W (4 x 10W)
Power dissipation	8W (4 x 2W)
Junction Temperature	115°C
ΔT inside package	5.6°C (0.7°C/W × 8W)
ΔT through thermal interface material	0.75°C (0.094°C/W × 8W)
Required heat sink thermal resistance	10.45°C/W ([115°C - 25°C - 5.6°C - 0.75°C] / 8W)
System thermal resistance to ambient $R_{\theta JA}$	11.24°C/W

14 器件和文档支持

14.1 文档支持

14.1.1 相关文档

请参阅如下相关文档:

- PurePath™ Console 3 图形开发套件
- 《TAS6424-Q1 EVM 用户指南》(文献编号: SLOU453)

14.2 接收文档更新通知

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14.6 术语表

SLYZ022 — TI 术语表。

这份术语表列出并解释术语、缩写和定义。



15 机械、封装和可订购信息

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
	()	()			(3)	(4)	(5)		(-,
TAS6424MQDKQRQ1	Active	Production	HSSOP (DKQ) 56	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TAS 6424M
TAS6424MQDKQRQ1.A	Active	Production	HSSOP (DKQ) 56	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TAS 6424M
TAS6424MQDKQRQ1.B	Active	Production	HSSOP (DKQ) 56	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TAS 6424M

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

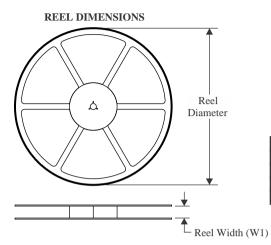
⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

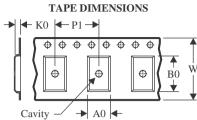
⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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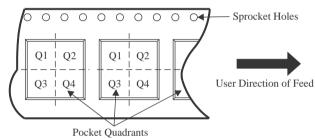
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

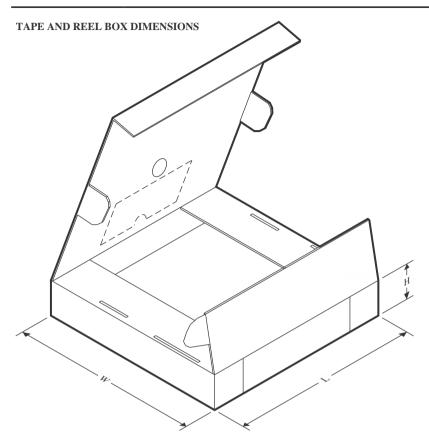


*All dimensions are nominal

Device	Package Type	Package Drawing	l .	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TAS6424MQDKQRQ1	HSSOP	DKQ	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1
TAS6424MQDKQRQ1	HSSOP	DKQ	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1

PACKAGE MATERIALS INFORMATION

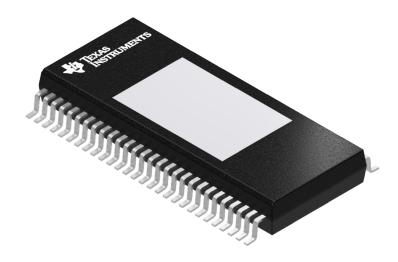
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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TAS6424MQDKQRQ1	HSSOP	DKQ	56	1000	356.0	356.0	53.0
TAS6424MQDKQRQ1	HSSOP	DKQ	56	1000	356.0	356.0	53.0

PLASTIC SMALL OUTLINE



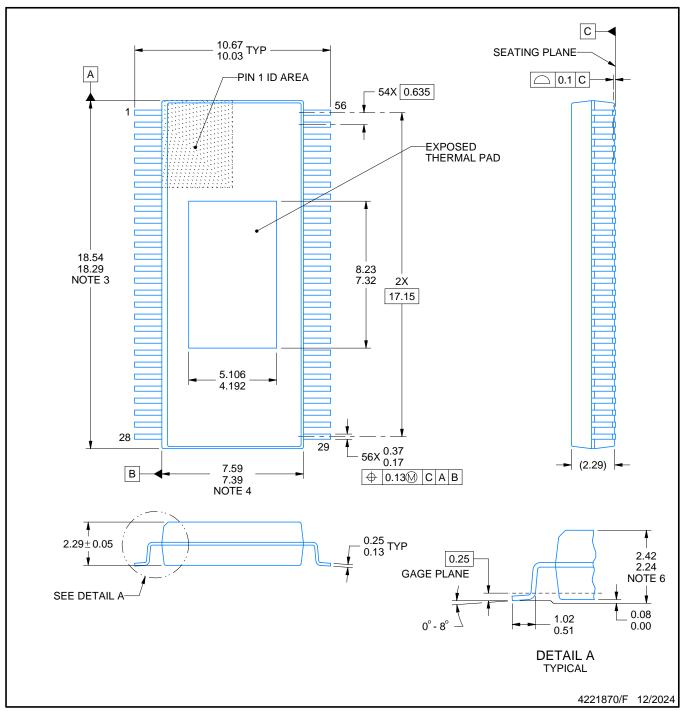
Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4211915-3/B



PowerPAD™ HSSOP - 2.475 mm max height

PLASTIC SMALL OUTLINE



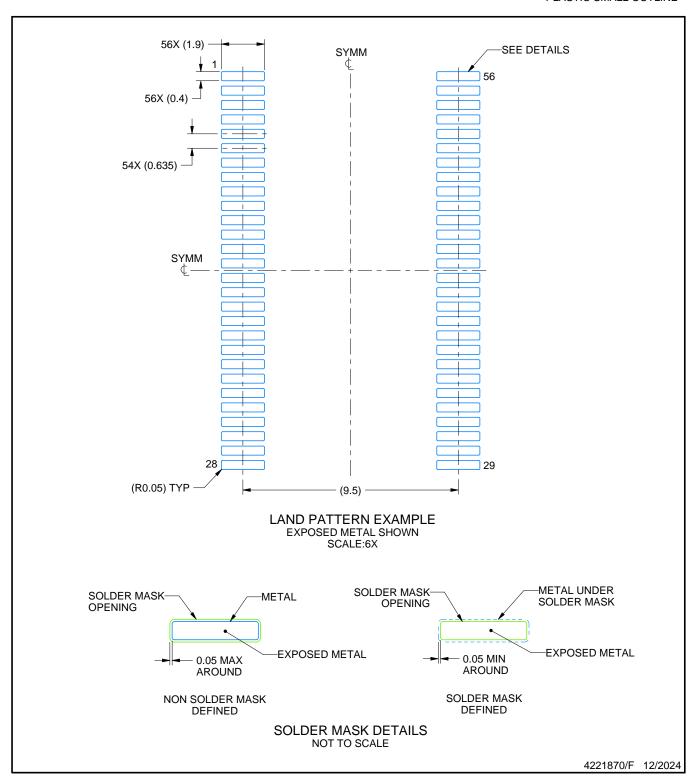
NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. The exposed thermal pad is designed to be attached to an external heatsink.
- 6. For clamped heatsink design, refer to overall package height above the seating plane as 2.33 +/- 0.09 and molded body thickness dimension.



PLASTIC SMALL OUTLINE

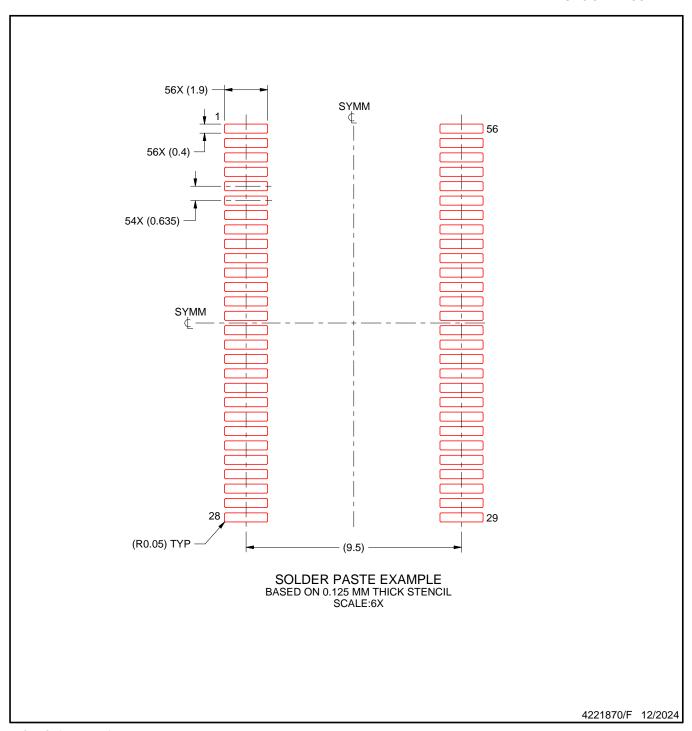


NOTES: (continued)

- 7. Publication IPC-7351 may have alternate designs.
- 8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 9. Size of metal pad may vary due to creepage requirement.



PLASTIC SMALL OUTLINE



NOTES: (continued)



^{10.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

^{11.} Board assembly site may have different recommendations for stencil design.

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